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Product Reference Information

Part Number: XMC1301Q024F0016ABXUMA1

Manufacturer: Infineon Technologies

Package: 24-VFQFN Exposed Pad

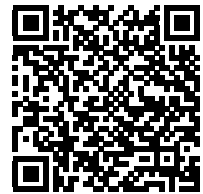
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Note:

This PDF includes an ANTREX product reference cover page.

The original manufacturer datasheet follows from the next page.

XMC1300 AB-Step

Microcontroller Series for Industrial Applications

ARM® Cortex® -M0
32-bit processor core

About this Document

This datasheet is addressed to embedded hardware and software developers. It provides the reader with detailed descriptions about the ordering designations, available features, electrical and physical characteristics of the XMC1300 series devices.

The document describes the characteristics of a superset of the XMC1300 series devices. For simplicity, the various device types are referred to by the collective term XMC1300 throughout this document.

XMC1000 Family User Documentation

The set of user documentation includes:

- **Reference Manual**
 - describes the functionality of the superset of devices.
- **Datasheets**
 - list the complete ordering designations, available features and electrical characteristics of derivative devices.
- **Errata Sheets**
 - list deviations from the specifications given in the related Reference Manual or Datasheets. Errata Sheets are provided for the superset of devices.

Attention: *Please consult all parts of the documentation set to attain consolidated knowledge about your device.*

Application related guidance is provided by **Users Guides** and **Application Notes**.

Please refer to <http://www.infineon.com/xmc1000> to get access to the latest versions of those documents.

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1 Summary of Features

1 Summary of Features

The XMC1300 devices are members of the XMC1000 Family of microcontrollers based on the ARM Cortex-M0 processor core. The XMC1300 series addresses the real-time control needs of motor control, digital power conversion. It also features peripherals for LED Lighting applications.

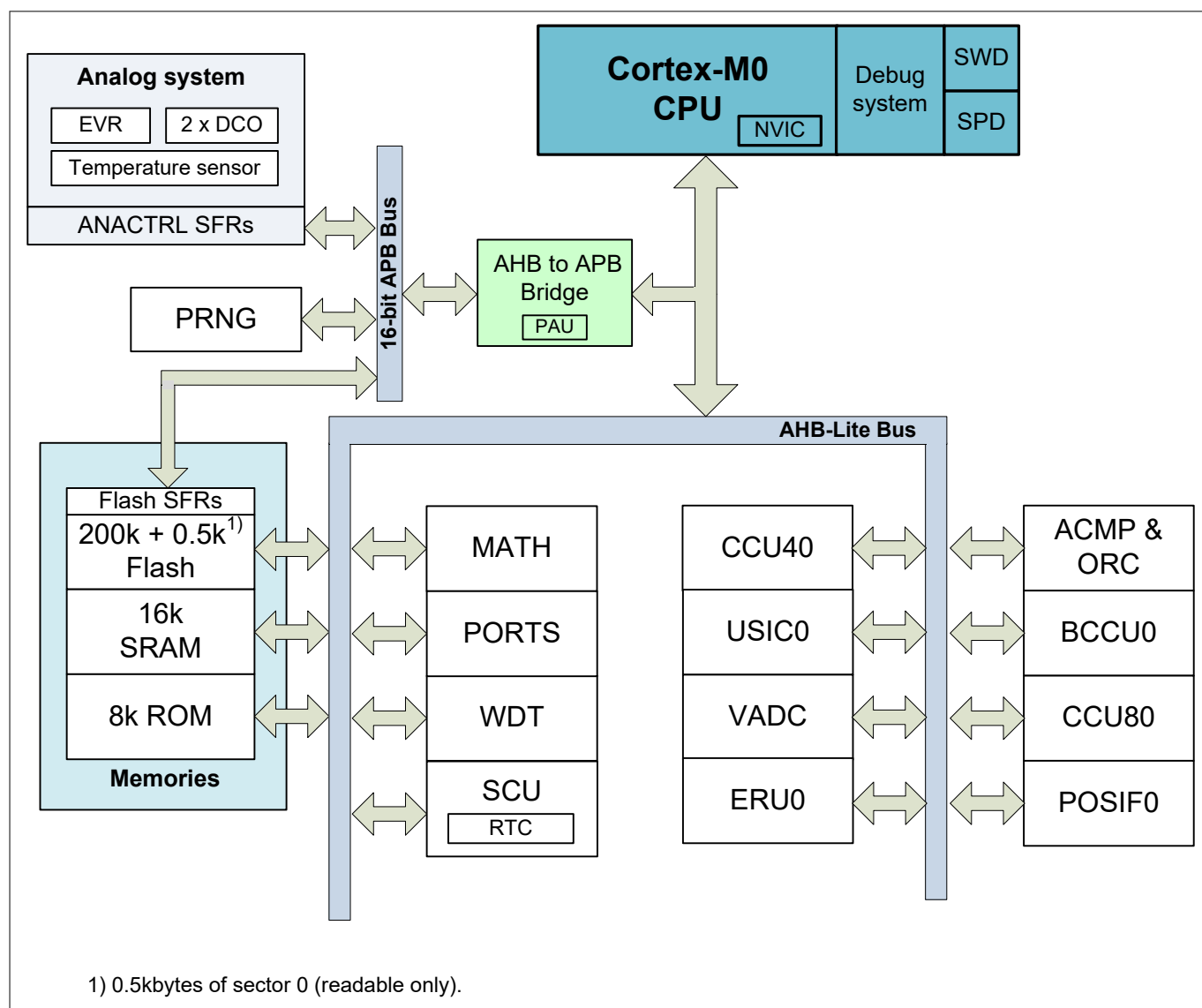


Figure 1 System Block Diagram

CPU Subsystem

- CPU Core
 - High-performance 32-bit ARM Cortex-M0 CPU
 - Most 16-bit Thumb and subset of 32-bit Thumb2 instruction set
 - Single cycle 32-bit hardware multiplier
 - System timer (SysTick) for Operating System support
 - Ultra low power consumption
- Nested Vectored Interrupt Controller (NVIC)

1 Summary of Features

- Event Request Unit (ERU) for processing of external and internal service requests
- MATH Co-processor (MATH)
 - CORDIC unit for trigonometric calculation
 - division unit

On-Chip Memories

- 8 kbytes on-chip ROM
- 16 kbytes on-chip high-speed SRAM
- up to 200 kbytes on-chip Flash program and data memory

Communication Peripherals

- Two Universal Serial Interface Channels (USIC), usable as UART, double-SPI, quad-SPI, IIC, IIS and LIN interfaces

Analog Frontend Peripherals

- A/D Converters
 - up to 12 analog input pins
 - 2 sample and hold stages with 8 analog input channels each
 - fast 12-bit analog to digital converter with adjustable gain
- Up to 8 channels of out of range comparators (ORC)
- Up to 3 fast analog comparators (ACMP)
- Temperature Sensor (TSE)

Industrial Control Peripherals

- Capture/Compare Units 4 (CCU4) as general purpose timers
- Capture/Compare Units 8 (CCU8) for motor control and power conversion
- Position Interfaces (POSIF) for hall and quadrature encoders and motor positioning
- Brightness and Colour Control Unit (BCCU), for LED color and dimming application

System Control

- Window Watchdog Timer (WDT) for safety sensitive applications
- Real Time Clock module with alarm support (RTC)
- System Control Unit (SCU) for system configuration and control
- Pseudo random number generator (PRNG) for fast random data generation

Input/Output Lines

- Tri-stated in input mode
- Push/pull or open drain output mode
- Configurable pad hysteresis

On-Chip Debug Support

- Support for debug features: 4 breakpoints, 2 watchpoints
- Various interfaces: ARM serial wire debug (SWD), single pin debug (SPD)

1 Summary of Features

1.1 Ordering Information

The ordering code for an Infineon microcontroller provides an exact reference to a specific product. The code “XMC1<DDD>-<Z><PPP><T><FFFF>” identifies:

- <DDD> the derivatives function set
- <Z> the package variant
 - T: TSSOP
 - Q: VQFN
- <PPP> package pin count
- <T> the temperature range:
 - F: -40°C to 85°C
 - X: -40°C to 105°C
- <FFFF> the Flash memory size

For ordering codes for the XMC1300 please contact your sales representative or local distributor.

This document describes several derivatives of the XMC1300 series, some descriptions may not apply to a specific product. Please see [Table 1](#).

For simplicity the term **XMC1300** is used for all derivatives throughout this document.

1.2 Device Types

These device types are available and can be ordered through Infineon’s direct and/or distribution channels.

Table 1 **Synopsis of XMC1300 Device Types**

Derivative	Package	Flash Kbytes	SRAM Kbytes
XMC1301-T016F0008	PG-TSSOP-16-8	8	16
XMC1301-T016F0016	PG-TSSOP-16-8	16	16
XMC1301-T016F0032	PG-TSSOP-16-8	32	16
XMC1301-T016X0008	PG-TSSOP-16-8	8	16
XMC1301-T016X0016	PG-TSSOP-16-8	16	16
XMC1302-T016X0008	PG-TSSOP-16-8	8	16
XMC1302-T016X0016	PG-TSSOP-16-8	16	16
XMC1302-T016X0032	PG-TSSOP-16-8	32	16
XMC1302-T028X0016	PG-TSSOP-28-8	16	16
XMC1302-T028X0032	PG-TSSOP-28-8	32	16
XMC1302-T028X0064	PG-TSSOP-28-8	64	16
XMC1302-T028X0128	PG-TSSOP-28-8	128	16
XMC1302-T028X0200	PG-TSSOP-28-8	200	16
XMC1301-T038F0008	PG-TSSOP-38-9	8	16
XMC1301-T038F0016	PG-TSSOP-38-9	16	16
XMC1301-T038F0032	PG-TSSOP-38-9	32	16
XMC1301-T038X0032	PG-TSSOP-38-9	32	16

(table continues...)

1 Summary of Features

Table 1 (continued) Synopsis of XMC1300 Device Types

Derivative	Package	Flash Kbytes	SRAM Kbytes
XMC1301-T038F0064	PG-TSSOP-38-9	64	16
XMC1302-T038X0016	PG-TSSOP-38-9	16	16
XMC1302-T038X0032	PG-TSSOP-38-9	32	16
XMC1302-T038X0064	PG-TSSOP-38-9	64	16
XMC1302-T038X0128	PG-TSSOP-38-9	128	16
XMC1302-T038X0200	PG-TSSOP-38-9	200	16
XMC1301-Q024F0008	PG-VQFN-24-19	8	16
XMC1301-Q024F0016	PG-VQFN-24-19	16	16
XMC1302-Q024F0016	PG-VQFN-24-19	16	16
XMC1302-Q024F0032	PG-VQFN-24-19	32	16
XMC1302-Q024F0064	PG-VQFN-24-19	64	16
XMC1302-Q024X0016	PG-VQFN-24-19	16	16
XMC1302-Q024X0032	PG-VQFN-24-19	32	16
XMC1302-Q024X0064	PG-VQFN-24-19	64	16
XMC1301-Q040F0008	PG-VQFN-40-13	8	16
XMC1301-Q040F0016	PG-VQFN-40-13	16	16
XMC1301-Q040F0032	PG-VQFN-40-13	32	16
XMC1302-Q040X0016	PG-VQFN-40-13	16	16
XMC1302-Q040X0032	PG-VQFN-40-13	32	16
XMC1302-Q040X0064	PG-VQFN-40-13	64	16
XMC1302-Q040X0128	PG-VQFN-40-13	128	16
XMC1302-Q040X0200	PG-VQFN-40-13	200	16

1.3 Device Type Features

The following table lists the available features per device type.

Table 2 Features of XMC1300 Device Types¹⁾

Derivative	ADC channel	ACMP	BCCU	MATH
XMC1301-T016	11	2	–	–
XMC1302-T016	11	2	1	1
XMC1302-T028	14	3	1	1
XMC1301-T038	16	3	–	–
XMC1302-T038	16	3	1	1
XMC1301-Q024	13	3	–	–

(table continues...)

1 Summary of Features

Table 2 (continued) Features of XMC1300 Device Types¹⁾

Derivative	ADC channel	ACMP	BCCU	MATH
XMC1302-Q024	13	3	1	1
XMC1301-Q040	16	3	–	–
XMC1302-Q040	16	3	1	1

1) Features that are not included in this table are available in all the derivatives.

Table 3 ADC Channels¹⁾

Package	VADC0 G0	VADC0 G1
PG-TSSOP-16	CH0..CH5	CH0..CH4
PG-TSSOP-28	CH0..CH7	CH0 .. CH4, CH7
PG-TSSOP-38	CH0..CH7	CH0..CH7
PG-VQFN-24	CH0..CH7	CH0..CH4
PG-VQFN-40	CH0..CH7	CH0..CH7

1) Some pins in a package may be connected to more than one channel. For the detailed mapping see the Port I/O Function table.

1.4 Chip Identification Number

The Chip Identification Number allows software to identify the marking. It is a 8 words value with the most significant 7 words stored in Flash configuration sector 0 (CS0) at address location : 1000 0F00_H (MSB) - 1000 0F1B_H (LSB). The least significant word and most significant word of the Chip Identification Number are the value of registers DBGROMID and IDCHIP, respectively.

Table 4 XMC1300 Chip Identification Number

Derivative	Value	Marking
XMC1301-T016F0008	00013032 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-T016F0016	00013032 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1301-T016F0032	00013032 01CF00FF 00001FF7 0000100F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1301-T016X0008	00013033 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-T016X0016	00013033 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-T016X0008	00013033 01FF00FF 00001FF7 0000900F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1302-T016X0016	00013033 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-T016X0032	00013033 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB

(table continues...)

1 Summary of Features

Table 4 (continued) **XMC1300 Chip Identification Number**

Derivative	Value	Marking
XMC1302-T028X0016	00013023 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-T028X0032	00013023 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-T028X0064	00013023 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1302-T028X0128	00013023 01FF00FF 00001FF7 0000900F 00000C00 00001000 00021000 201ED083 _H	AB
XMC1302-T028X0200	00013023 01FF00FF 00001FF7 0000900F 00000C00 00001000 00033000 201ED083 _H	AB
XMC1301-T038F0008	00013012 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-T038F0016	00013012 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1301-T038F0032	00013012 01CF00FF 00001FF7 0000100F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1301-T038X0032	00013013 01CF00FF 00001FF7 0000100F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1301-T038F0064	00013012 01CF00FF 00001FF7 0000100F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1302-T038X0016	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-T038X0032	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-T038X0064	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1302-T038X0128	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00021000 201ED083 _H	AB
XMC1302-T038X0200	00013013 01FF00FF 00001FF7 0000900F 00000C00 00001000 00033000 201ED083 _H	AB
XMC1301-Q024F0008	00013062 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-Q024F0016	00013062 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q024F0016	00013062 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q024F0032	00013062 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB

(table continues...)

1 Summary of Features

Table 4 (continued) **XMC1300 Chip Identification Number**

Derivative	Value	Marking
XMC1302-Q024F0064	00013062 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1302-Q024X0016	00013063 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q024X0032	00013063 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q024X0064	00013063 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1301-Q040F0008	00013042 01CF00FF 00001FF7 0000100F 00000C00 00001000 00003000 201ED083 _H	AB
XMC1301-Q040F0016	00013042 01CF00FF 00001FF7 0000100F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1301-Q040F0032	00013042 01CF00FF 00001FF7 0000100F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q040X0016	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00005000 201ED083 _H	AB
XMC1302-Q040X0032	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00009000 201ED083 _H	AB
XMC1302-Q040X0064	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00011000 201ED083 _H	AB
XMC1302-Q040X0128	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00021000 201ED083 _H	AB
XMC1302-Q040X0200	00013043 01FF00FF 00001FF7 0000900F 00000C00 00001000 00033000 201ED083 _H	AB

2 General Device Information

This section summarizes the logic symbols and package pin configurations with a detailed list of the functional I/O mapping.

2.1 Logic Symbols

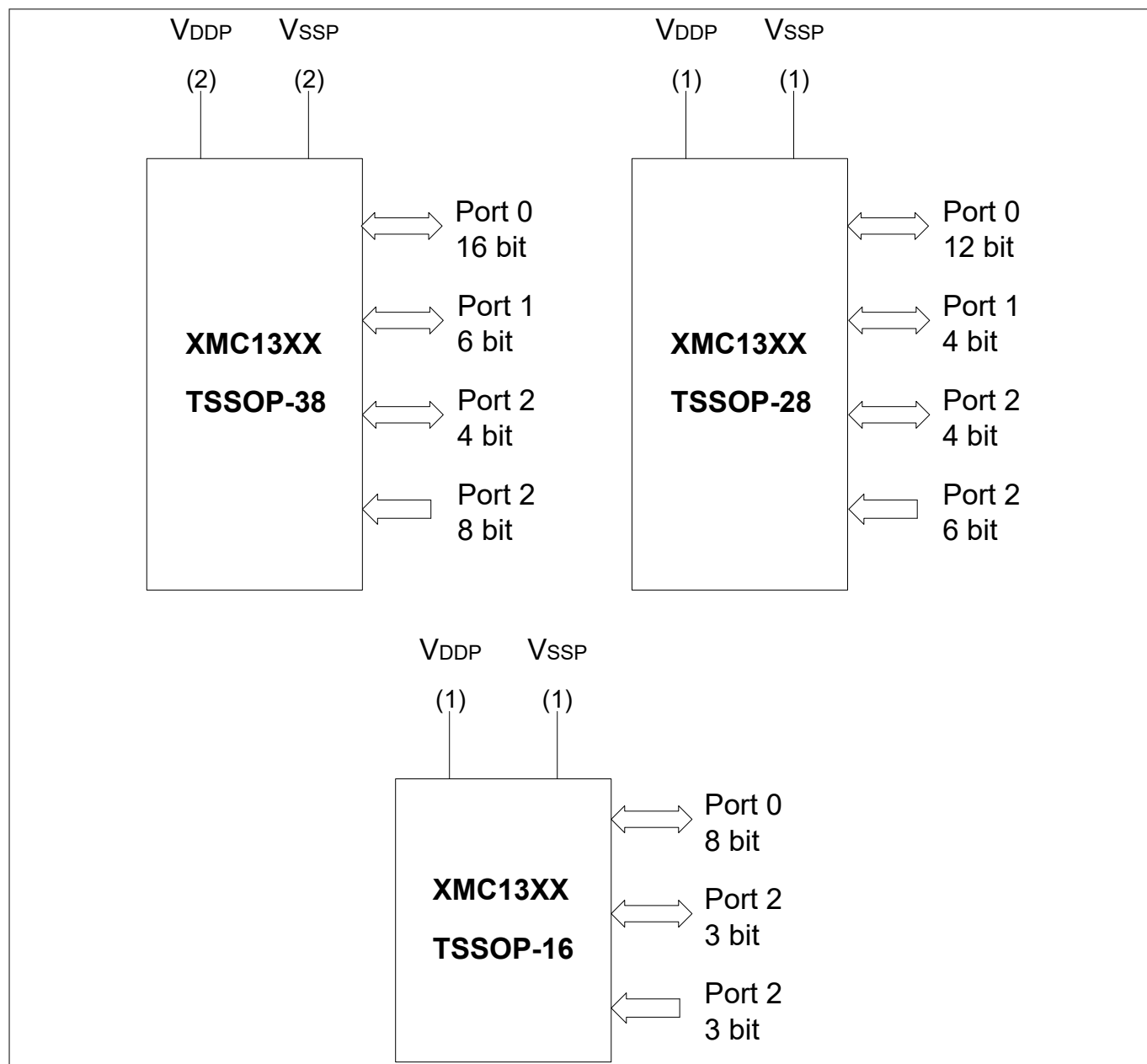


Figure 2 XMC1300 Logic Symbol for TSSOP-38, TSSOP-28 and TSSOP-16

2 General Device Information

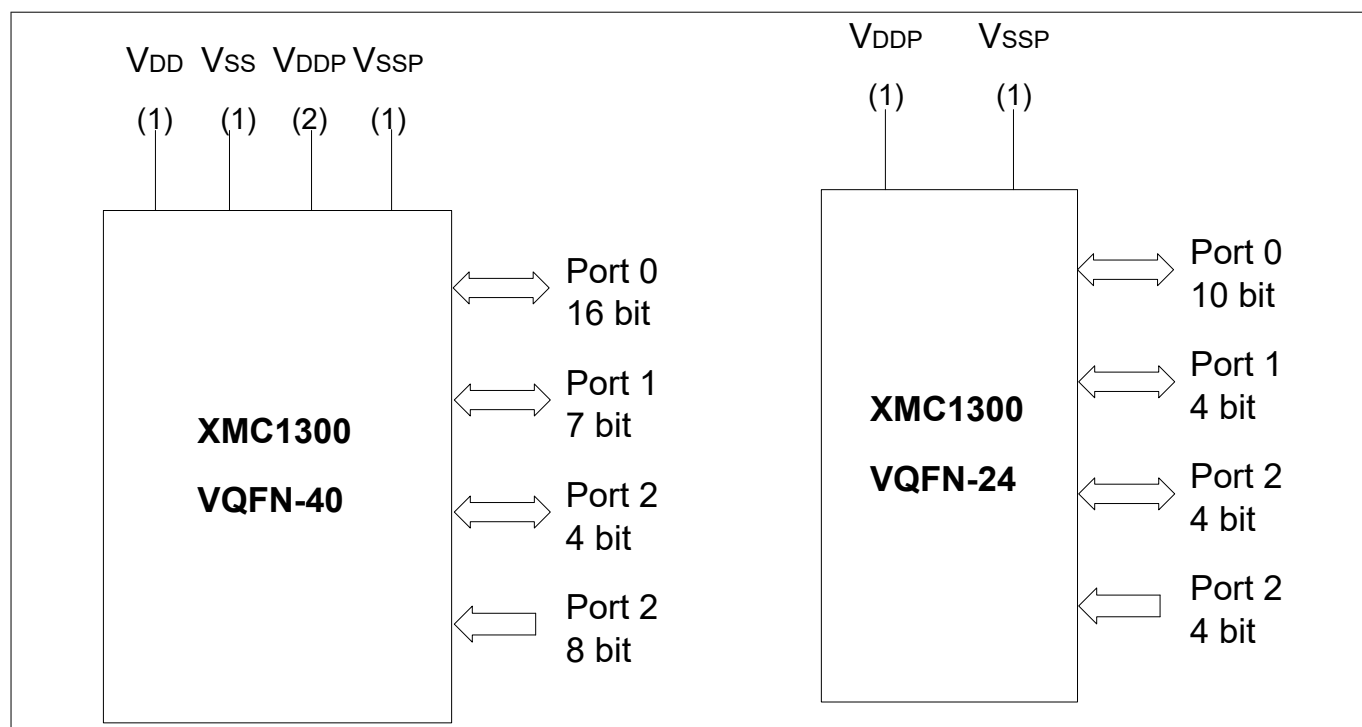


Figure 3 XMC1300 Logic Symbol for VQFN-24 and VQFN-40

2 General Device Information

2.2 Pin Configuration and Definition

The following figures summarize all pins, showing their locations on the different packages.

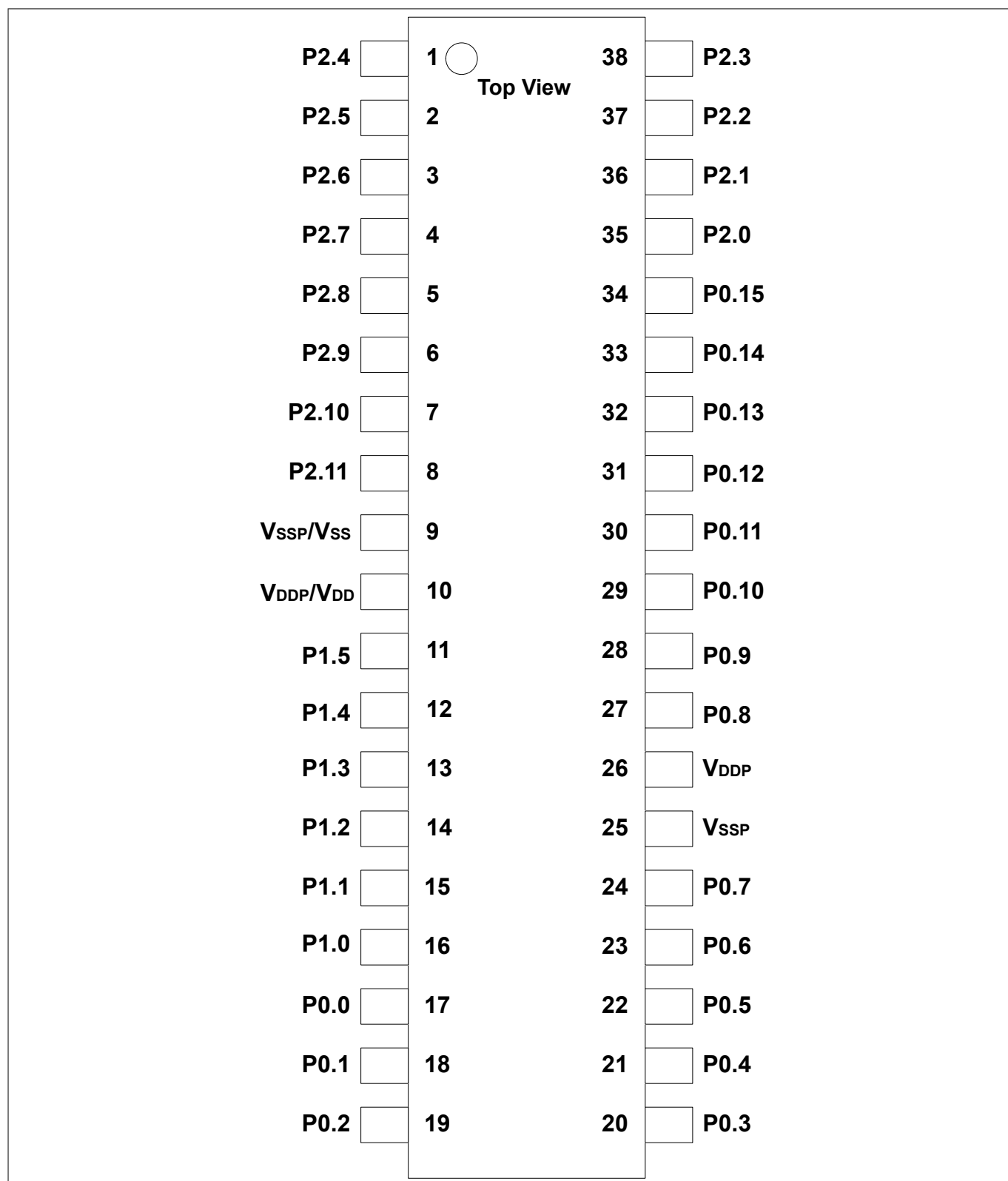


Figure 4 XMC1300 PG-TSSOP-38 Pin Configuration (top view)

2 General Device Information

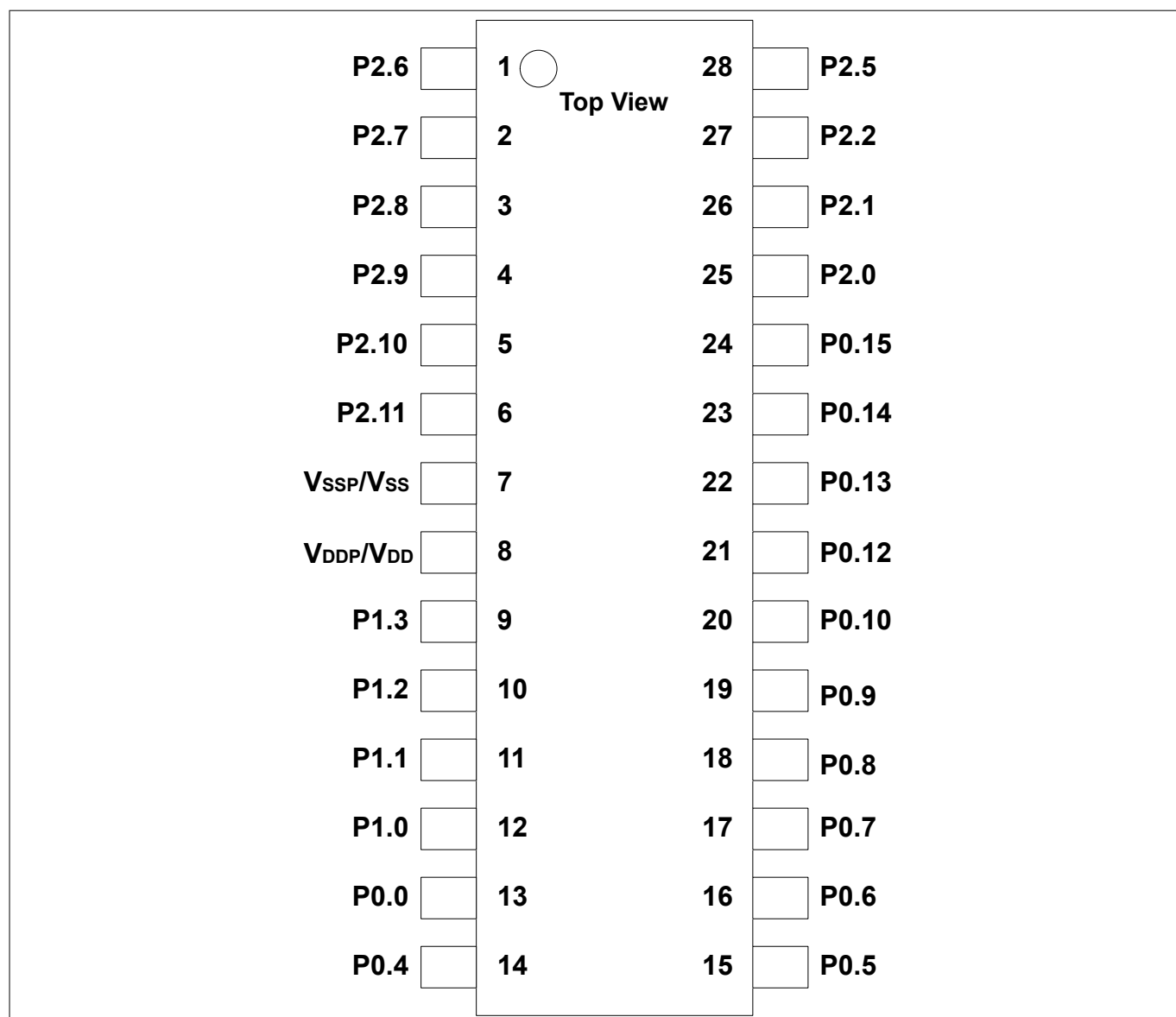


Figure 5 XMC1300 PG-TSSOP-28 Pin Configuration (top view)

2 General Device Information

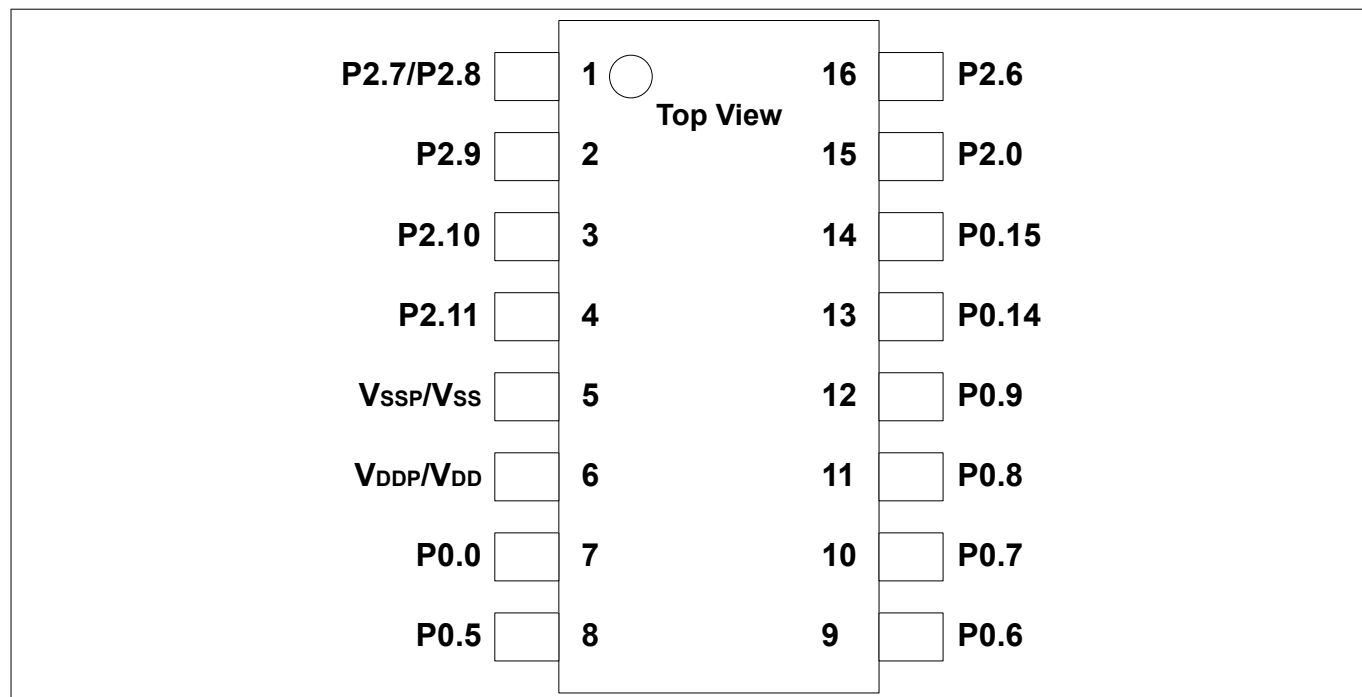


Figure 6 XMC1300 PG-TSSOP-16 Pin Configuration (top view)

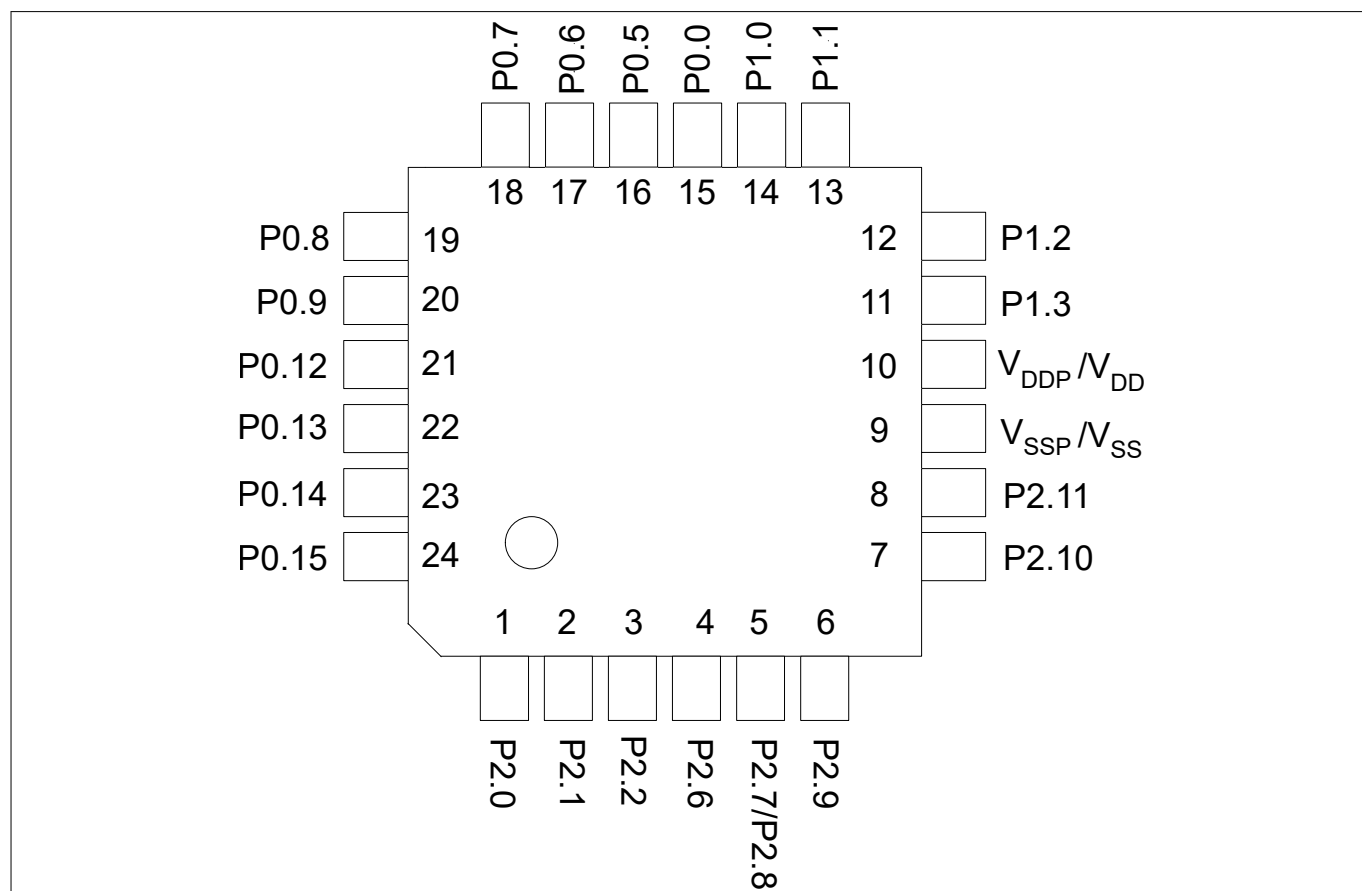


Figure 7 XMC1300 PG-VQFN-24 Pin Configuration (top view)

2 General Device Information

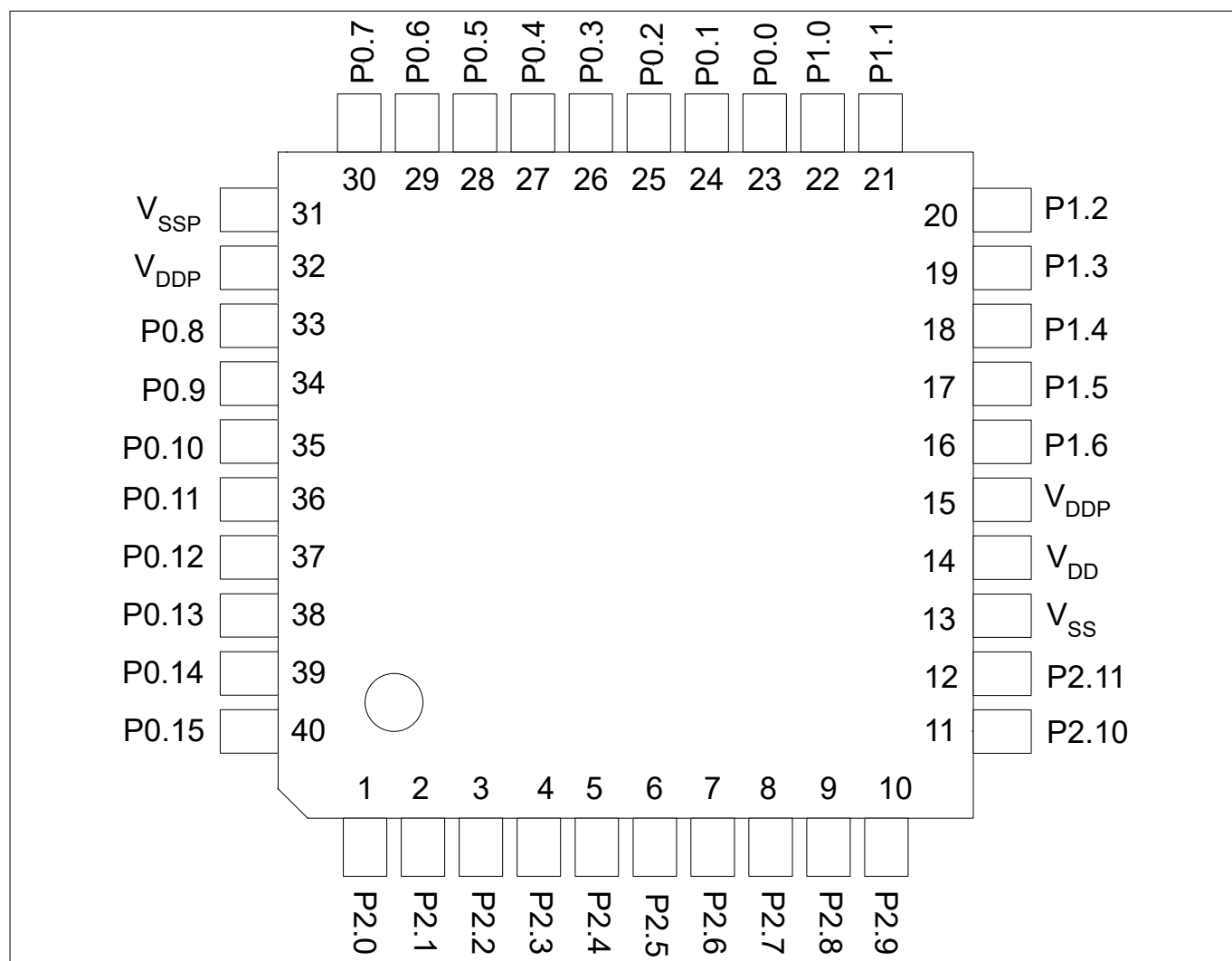


Figure 8 XMC1300 PG-VQFN-40 Pin Configuration (top view)

2 General Device Information

2.2.1 Package Pin Summary

The following general building block is used to describe each pin:

Table 5 Package Pin Mapping Description

Function	Package A	Package B	...	Pad Type
Px.y	N	N		Pad Class

The table is sorted by the “Function” column, starting with the regular Port pins (Px.y), followed by the supply pins.

The following columns, titled with the supported package variants, lists the package pin number to which the respective function is mapped in that package.

The “Pad Type” indicates the employed pad type:

- STD_INOUT(standard bi-directional pads)
- STD_INOUT/AN (standard bi-directional pads with analog input)
- High Current (high current bi-directional pads)
- STD_IN/AN (standard input pads with analog input)
- Power (power supply)

Details about the pad properties are defined in the Electrical Parameters.

Table 6 Package Pin Mapping

Function	VQFN 40	TSSOP 38	TSSOP 28	VQFN 24	TSSOP 16	Pad Type	Notes
P0.0	23	17	13	15	7	STD_INOUT	
P0.1	24	18	–	–	–	STD_INOUT	
P0.2	25	19	–	–	–	STD_INOUT	
P0.3	26	20	–	–	–	STD_INOUT	
P0.4	27	21	14	–	–	STD_INOUT	
P0.5	28	22	15	16	8	STD_INOUT	
P0.6	29	23	16	17	9	STD_INOUT	
P0.7	30	24	17	18	10	STD_INOUT	
P0.8	33	27	18	19	11	STD_INOUT	
P0.9	34	28	19	20	12	STD_INOUT	
P0.10	35	29	20	–	–	STD_INOUT	
P0.11	36	30	–	–	–	STD_INOUT	
P0.12	37	31	21	21	–	STD_INOUT	
P0.13	38	32	22	22	–	STD_INOUT	
P0.14	39	33	23	23	13	STD_INOUT	
P0.15	40	34	24	24	14	STD_INOUT	
P1.0	22	16	12	14	–	High Current	
P1.1	21	15	11	13	–	High Current	
P1.2	20	14	10	12	–	High Current	

(table continues...)

2 General Device Information

Table 6 (continued) Package Pin Mapping

Function	VQFN 40	TSSOP 38	TSSOP 28	VQFN 24	TSSOP 16	Pad Type	Notes
P1.3	19	13	9	11	–	High Current	
P1.4	18	12	–	–	–	High Current	
P1.5	17	11	–	–	–	High Current	
P1.6	16	–	–	–	–	STD_INOUT	
P2.0	1	35	25	1	15	STD_INOUT/ AN	
P2.1	2	36	26	2	–	STD_INOUT/ AN	
P2.2	3	37	27	3	–	STD_IN/AN	
P2.3	4	38	–	–	–	STD_IN/AN	
P2.4	5	1	–	–	–	STD_IN/AN	
P2.5	6	2	28	–	–	STD_IN/AN	
P2.6	7	3	1	4	16	STD_IN/AN	
P2.7	8	4	2	5	1	STD_IN/AN	
P2.8	9	5	3	5	1	STD_IN/AN	
P2.9	10	6	4	6	2	STD_IN/AN	
P2.10	11	7	5	7	3	STD_INOUT/ AN	
P2.11	12	8	6	8	4	STD_INOUT/ AN	
VSS	13	9	7	9	5	Power	Supply GND, ADC reference GND
VDD	14	10	8	10	6	Power	Supply VDD, ADC reference voltage/ORC reference voltage
VDDP	15	10	8	10	6	Power	When VDD is supplied, VDDP has to be supplied with the same voltage.
VSSP	31	25	–	–	–	Power	I/O port ground
VDDP	32	26	–	–	–	Power	I/O port supply

(table continues...)

2 General Device Information

Table 6 (continued) Package Pin Mapping

Function	VQFN 40	TSSOP 38	TSSOP 28	VQFN 24	TSSOP 16	Pad Type	Notes
VSSP	Exp. Pad	–	–	Exp. Pad	–	Power	Exposed Die Pad The exposed die pad is connected internally to VSSP. For proper operation, it is mandatory to connect the exposed pad to the board ground. For thermal aspects, please refer to the Package and Reliability chapter.

2.2.2 Port I/O Function Description

The following general building block is used to describe the I/O functions of each PORT pin:

Table 7 Port I/O Function Description

Function	Outputs		Inputs	
	ALT1	ALTn	Input	Input
P0.0		MODA.OUT	MODC.INA	
Pn.y	MODA.OUT		MODA.INA	MODC.INB

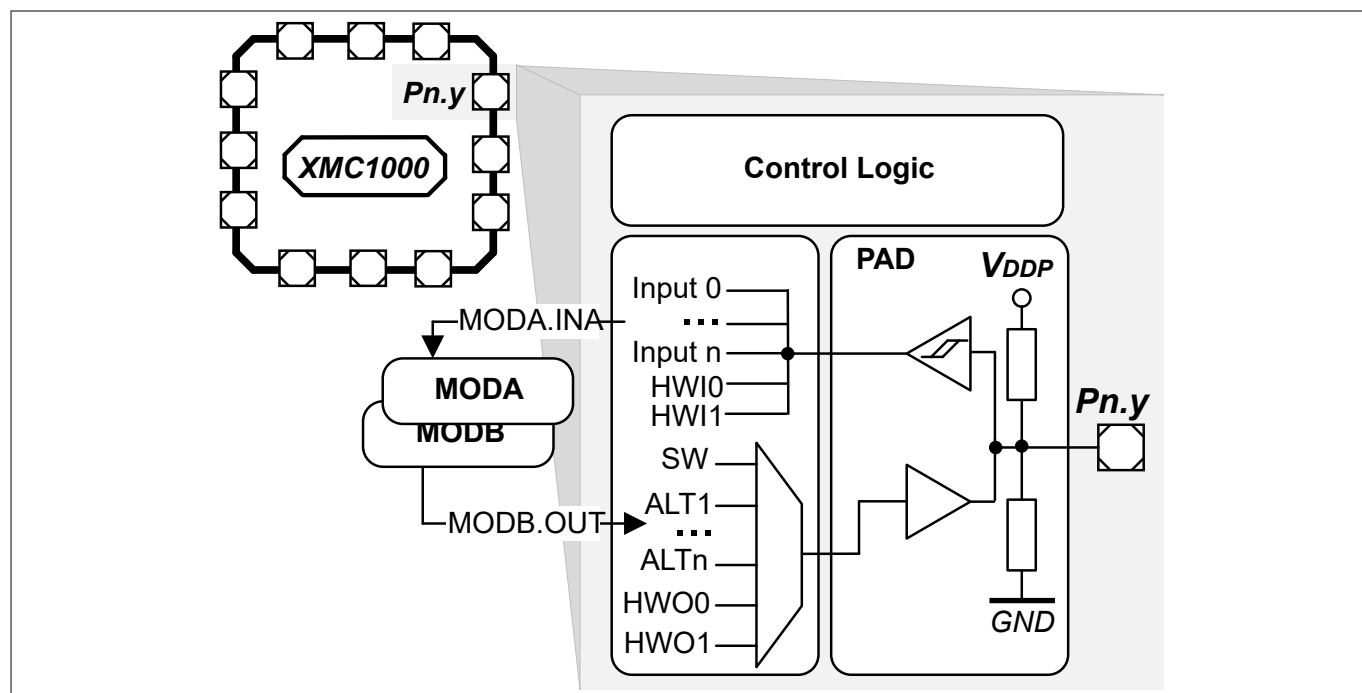


Figure 9 Simplified Port Structure

2 General Device Information

Pn.y is the port pin name, defining the control and data bits/registers associated with it. As GPIO, the port is under software control. Its input value is read via Pn_IN.y, Pn_OUT defines the output value.

Up to seven alternate output functions (ALT1/2/3/4/5/6/7) can be mapped to a single port pin, selected by Pn_IOC.R.PC. The output value is directly driven by the respective module, with the pin characteristics controlled by the port registers (within the limits of the connected pad).

The port pin input can be connected to multiple peripherals. Most peripherals have an input multiplexer to select between different possible input sources.

The input path is also active while the pin is configured as output. This allows to feedback an output to on-chip resources without wasting an additional external pin.

Please refer to [Table 9](#) for the complete Port I/O function mapping.

2.2.3 Hardware Controlled I/O Function Description

The following general building block is used to describe the hardware I/O and pull control functions of each PORT pin:

Table 8 Hardware Controlled I/O Function Description

Function	Outputs	Inputs	Pull Control	
	HW00	HWI0	HW0_PD	HW0_PU
P0.0	MODB.OUT	MODB.INA		
Pn.y			MODC.OUT	MODC.OUT

By Pn_HWSEL, it is possible to select between different hardware “masters” (HW00/HWI0, HW01/HWI1). The selected peripheral can take control of the pin(s). Hardware control overrules settings in the respective port pin registers. Additional hardware signals HW0_PD/HW1_PD and HW0_PU/HW1_PU controlled by the peripherals can be used to control the pull devices of the pin.

Please refer to [Table 10](#) for the complete hardware I/O and pull control function mapping.

2 General Device Information

Table 9 Port I/O Functions

Function	Outputs						Inputs							
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	Input	Input	Input	Input	Input	Input	Input
P0.0	ERU0. PDOU T0		ERU0. GOUT 0	CCU4 0. OUT0	CCU8 0. OUT0 0	USIC0 _C H0.SE LO 0	USIC0 _C H1.SE LO 0	BCCU 0. TRAPI NB	CCU4 0. IN0C		USIC0 _C H0.DX 2A	USIC0 _C H1.DX 2A		
P0.1	ERU0. PDOU T1		ERU0. GOUT 1	CCU4 0. OUT1	CCU8 0. OUT0 1	BCCU 0. OUT8 P	SCU. VDRO P		CCU4 0. IN1C					
P0.2	ERU0. PDOU T2		ERU0. GOUT 2	CCU4 0. OUT2	CCU8 0. OUT0 2	VADC 0. EMUX 02	CCU8 0. OUT1 0		CCU4 0. IN2C					
P0.3	ERU0. PDOU T3		ERU0. GOUT 3	CCU4 0. OUT3	CCU8 0. OUT0 3	VADC 0. EMUX 01	CCU8 0. OUT1 1		CCU4 0. IN3C					
P0.4	BCCU 0. OUT0			CCU4 0. OUT1	CCU8 0. OUT1 3	VADC 0. EMUX 00	WWD T. SERVI CE _OUT		CCU8 0. IN0B					
P0.5	BCCU 0. OUT1			CCU4 0. OUT0	CCU8 0. OUT1 2	ACMP 2. OUT 0	CCU8 0. OUT0 1		CCU8 0. IN1B					

(table continues...)

2 General Device Information

Table 9 (continued) Port I/O Functions

Function	Outputs							Inputs						
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	Input	Input	Input	Input	Input	Input	Input
P0.6	BCCU 0. OUT2			CCU4 0. OUT0	CCU8 0. OUT1 1	USIC0 _C H1.M CLK OUT	USIC0 _C H1.D OUT 0		CCU4 0. IN0B			USIC0 _C H1.DX 0C		
P0.7	BCCU 0. OUT3			CCU4 0. OUT1	CCU8 0. OUT1 0	USIC0 _C H0.SC LK OUT	USIC0 _C H1.D OUT 0		CCU4 0. IN1B			USIC0 _C H0.DX 1C USIC0 _C H1.DX 0D 1C		
P0.8	BCCU 0. OUT4			CCU4 0. OUT2	CCU8 0. OUT2 0	USIC0 _C H0.SC LK OUT	USIC0 _C H1.SC LK OUT		CCU4 0. IN2B			USIC0 _C H0.DX 1B USIC0 _C H1.DX 1B		
P0.9	BCCU 0. OUT5			CCU4 0. OUT3	CCU8 0. OUT2 1	USIC0 _C H0.SE LO 0	USIC0 _C H1.SE LO 0		CCU4 0. IN3B			USIC0 _C H0.DX 2B USIC0 _C H1.DX 2B		
P0.10	BCCU 0. OUT6			ACMP 0. OUT	CCU8 0. OUT2 2	USIC0 _C H0.SE LO 1	USIC0 _C H1.SE LO 1		CCU8 0. IN2B			USIC0 _C H0.DX 2C USIC0 _C H1.DX 2C		
P0.11	BCCU 0. OUT7			USIC0 _C H0.M CLK OUT	CCU8 0. OUT2 3	USIC0 _C H0.SE LO 2	USIC0 _C H1.SE LO 2					USIC0 _C H0.DX 2D USIC0 _C H1.DX 2D		
(table continues...)														

2 General Device Information

Table 9 (continued) Port I/O Functions

Function	Outputs							Inputs									
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	Input	Input	Input	Input	Input	Input	Input	Input	Input	
P0.12	BCCU 0. OUT6				CCU8 0. OUT3 3	USIC0 _C H0.SE LO 3	CCU8 0. OUT2 0	BCCU 0. TRAPI NA	CCU4 0. IN0A	CCU4 0. IN1A	CCU4 0. IN2A	CCU4 0. IN3A	CCU8 0. IN0A	CCU8 0. IN1A	CCU8 0. IN2A	CCU8 0. IN3A	USIC0 _C H0.DX 2E
P0.13	WWD T. SERVI CE _OUT				CCU8 0. OUT3 2	USIC0 _C H0.SE LO 4	CCU8 0. OUT2 1		CCU8 0. IN3B	POSIF 0. IN0B		USIC0 _C H0.DX 2F					
P0.14	BCCU 0. OUT7				CCU8 0. OUT3 1	USIC0 _C H0.D OUT0	USIC0 _C H0.SC LK OUT			POSIF 0. IN1B		USIC0 _C H0.DX 0A	USIC0 _C H0.DX 1A				
P0.15	BCCU 0. OUT8				CCU8 0. OUT3 0	USIC0 _C H0.D OUT0	USIC0 _C H1.M CLK OUT			POSIF 0. IN2B		USIC0 _C H0.DX 0B					
P1.0	BCCU 0. OUT0	CCU4 0. OUT0			CCU8 0. OUT0 0	ACMP 1. OUT	USIC0 _C H0.D OUT0			POSIF 0. IN2A		USIC0 _C H0.DX 0C					
P1.1	VADC 0. EMUX 00	CCU4 0. OUT1			CCU8 0. OUT0 1	USIC0 _C H0.D OUT0	USIC0 _C H1.SE LO 0			POSIF 0. IN1A		USIC0 _C H0.DX 0D	USIC0 _C H0.DX 1D	USIC0 _C H1.DX 2E			
(table continues...)																	

2 General Device Information

Table 9 (continued) Port I/O Functions

Function	Outputs							Inputs						
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	Input	Input	Input	Input	Input	Input	Input
P1.2	VADC 0. EMUX 01	CCU4 0. OUT2			CCU8 0. OUT1 0	ACMP 2. OUT	USIC0 _C H1.D OUT 0		POSIF 0. IN0A		USIC0 _C H1.DX 0B			
P1.3	VADC 0. EMUX 02	CCU4 0. OUT3			CCU8 0. OUT1 1	USIC0 _C H1.SC LK OUT	USIC0 _C H1.D OUT 0				USIC0 _C H1.DX 0A 1A			
P1.4	VADC 0. EMUX 10	USIC0 _C H1.SC LK OUT			CCU8 0. OUT2 0	USIC0 _C H0.SE LO 0	USIC0 _C H1.SE LO 1				USIC0 _C H0.DX 5E 5E			
P1.5	VADC 0. EMUX 11	USIC0 _C H0.D OUT 0			CCU8 0. OUT2 1	USIC0 _C H0.SE LO 1	USIC0 _C H1.SE LO 2				USIC0 _C H1.DX 5F			
P1.6	VADC 0. EMUX 12	USIC0 _C H1.D OUT 0			BCCU 0. OUT1	USIC0 _C H0.SC LO 2	USIC0 _C H1.SE LO 3		USIC0 _C H0.DX 5F					
P2.0	ERU0. PDOU T3	CCU4 0. OUT0	ERU0. GOUT 3		CCU8 0. OUT2 0	USIC0 _C H0.D OUT 0	USIC0 _C H0.SC LK OUT	VADC 0. G0CH 5		ERU0. 0B 0	USIC0 _C H0.DX 0E	USIC0 _C H0.DX 1E	USIC0 _C H1.DX 2F	

(table continues...)

2 General Device Information

Table 9 (continued) Port I/O Functions

Function	Outputs							Inputs						
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	Input	Input	Input	Input	Input	Input	Input
P2.1	ERU0. PDOU T2	CCU4 0. OUT1	ERU0. GOUT 2		CCU8 0. OUT2 1	USIC0 _C H0.D OUT0	USIC0 _C H1.SC LK OUT	ACMP 2.I NP	VADC 0. G0CH 6		ERU0. 1B0	USIC0 _C H0.DX 0F	USIC0 _C H1.DX 3A	USIC0 _C H1.DX 4A
P2.2								ACMP 2.I NN	VADC 0. G0CH 7		ERU0. 0B1	USIC0 _C H0.DX 3A	USIC0 _C H0.DX 4A	USIC0 _C H1.DX 5A
P2.3									VADC 0. G1CH 5		ERU0. 1B1	USIC0 _C H0.DX 5B	USIC0 _C H1.DX 3C	USIC0 _C H1.DX 4C
P2.4									VADC 0. G1CH 6		ERU0. 0A1	USIC0 _C H0.DX 3B	USIC0 _C H0.DX 4B	USIC0 _C H1.DX 5B
P2.5									VADC 0. G1CH 7		ERU0. 1A1	USIC0 _C H0.DX 5D	USIC0 _C H1.DX 3E	USIC0 _C H1.DX 4E
P2.6								ACMP 1.I NN	VADC 0. G0CH 0		ERU0. 2A1	USIC0 _C H0.DX 3E	USIC0 _C H0.DX 4E	USIC0 _C H1.DX 5D
P2.7								ACMP 1.I NP	VADC 0. G1CH 1		ERU0. 3A1	USIC0 _C H0.DX 5C	USIC0 _C H1.DX 3D	USIC0 _C H1.DX 4D

(table continues...)

2 General Device Information

Table 9 (continued) Port I/O Functions

Function	Outputs							Inputs									
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	Input	Input	Input	Input	Input	Input	Input	Input	Input	Input
P2.8								ACMP 0.I NN	VADC 0. G0CH 1	VADC 0. G1CH 0	ERU0. 3B1	USIC0 _C H0.DX 3D	USIC0 _C H0.DX 4D	USIC0 _C H1.DX 5C	ORC6. AIN		
P2.9								ACMP 0.I NP	VADC 0. G0CH 2	VADC 0. G1CH 4	ERU0. 3B0	USIC0 _C H0.DX 5A	USIC0 _C H1.DX 3B	USIC0 _C H1.DX 4B	ORC7. AIN		
P2.10	ERU0. PDOU T1	CCU4 0. OUT2	ERU0. GOUT 1		CCU8 0. OUT3 0	ACMP 0. OUT	USIC0 _C H1.D OUT 0		VADC 0. G0CH 3	VADC 0. G1CH 2	ERU0. 2B0	USIC0 _C H0.DX 3C	USIC0 _C H0.DX 4C	USIC0 _C H1.DX 0F			
P2.11	ERU0. PDOU T0	CCU4 0. OUT3	ERU0. GOUT 0		CCU8 0. OUT3 1	USIC0 _C H1.SC LK OUT	USIC0 _C H1.D OUT 0	ACMP. REF	VADC 0. G0CH 4	VADC 0. G1CH 3	ERU0. 2B1	USIC0 _C H1.DX 0E	USIC0 _C H1.DX 1E				

2 General Device Information

Table 10 Hardware Controlled I/O Functions

Function	Outputs		Inputs		Pull Control			
	HW00	HW01	HWI0	HWI1	HW0_PD	HW0_PU	HW1_PD	HW1_PU
P0.0								
P0.1								
P0.2								
P0.3								
P0.4								
P0.5								
P0.6								
P0.7								
P0.8								
P0.9								
P0.10								
P0.11								
P0.12								
P0.13								
P0.14								
P0.15								
P1.0		USIC0_CH0 .DOUT0		USIC0_CH0 .HWIN0	<u>BCCU0.OUT2</u>	BCCU0.OUT2		
P1.1		USIC0_CH0 .DOUT1		USIC0_CH0 .HWIN1	<u>BCCU0.OUT3</u>	BCCU0.OUT3		
P1.2		USIC0_CH0 .DOUT2		USIC0_CH0 .HWIN2	<u>BCCU0.OUT4</u>	BCCU0.OUT4		

(table continues...)

2 General Device Information

Table 10 (continued) Hardware Controlled I/O Functions

Function	Outputs		Inputs		Pull Control			
	HWO0	HWO1	HWI0	HWI1	HWO_PD	HW0_PU	HW1_PD	HW1_PU
P1.3		USIC0_CH0.DOUT3		USIC0_CH0.HWIN3	$\overline{\text{BCCU0.OUT5}}$	BCCU0.OUT5		
P1.4					$\overline{\text{BCCU0.OUT6}}$	BCCU0.OUT6		
P1.5					$\overline{\text{BCCU0.OUT7}}$	BCCU0.OUT7		
P1.6					$\overline{\text{BCCU0.OUT8}}$	BCCU0.OUT8		
P2.0					$\overline{\text{BCCU0.OUT1}}$	BCCU0.OUT1		
P2.1					$\overline{\text{BCCU0.OUT6}}$	BCCU0.OUT6		
P2.2					$\overline{\text{BCCU0.OUT0}}$	BCCU0.OUT0	$\overline{\text{CCU40.OUT3}}$	CCU40.OUT3
P2.3					$\overline{\text{ACMP2.OUT}}$	ACMP2.OUT		
P2.4					$\overline{\text{BCCU0.OUT8}}$	BCCU0.OUT8		
P2.5					$\overline{\text{ACMP1.OUT}}$	ACMP1.OUT		
P2.6					$\overline{\text{BCCU0.OUT2}}$	BCCU0.OUT2	$\overline{\text{CCU40.OUT3}}$	CCU40.OUT3
P2.7					$\overline{\text{BCCU0.OUT8}}$	BCCU0.OUT8	$\overline{\text{CCU40.OUT3}}$	CCU40.OUT3
P2.8					$\overline{\text{BCCU0.OUT1}}$	BCCU0.OUT1	$\overline{\text{CCU40.OUT2}}$	CCU40.OUT2
P2.9					$\overline{\text{BCCU0.OUT7}}$	BCCU0.OUT7	$\overline{\text{CCU40.OUT2}}$	CCU40.OUT2
P2.10					$\overline{\text{BCCU0.OUT4}}$	BCCU0.OUT4		
P2.11					$\overline{\text{BCCU0.OUT5}}$	BCCU0.OUT5		

3 Electrical Parameters

3 Electrical Parameters

This section provides the electrical parameters which are implementation-specific for the XMC1300.

3.1 General Parameters

3.1.1 Parameter Interpretation

The parameters listed in this section represent partly the characteristics of the XMC1300 and partly its requirements on the system. To aid interpreting the parameters easily when evaluating them for a design, they are indicated by the abbreviations in the “Symbol” column:

- **CC**
 Such parameters indicate **C**ontroller **C**haracteristics, which are distinctive feature of the XMC1300 and must be regarded for a system design.
- **SR**
 Such parameters indicate **S**ystem **R**equirements, which must be provided by the application system in which the XMC1300 is designed in.

3.1.2 Absolute Maximum Ratings

Stresses above the values listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Table 11 Absolute Maximum Rating Parameters

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Junction temperature	T_J SR	-40	–	115	°C	–
Storage temperature	T_{ST} SR	-40	–	125	°C	–
Voltage on power supply pin with respect to V_{SSP}	V_{DDP} SR	-0.3	–	6	V	–
Voltage on digital pins with respect to V_{SSP} ¹⁾	V_{IN} SR	-0.5	–	$V_{DDP} + 0.5$ or max. 6	V	whichever is lower
Voltage on P2 pins with respect to V_{SSP} ²⁾	V_{INP2} SR	-0.3	–	$V_{DDP} + 0.3$	V	–
Voltage on analog input pins with respect to V_{SSP}	V_{AIN} V_{AREF} SR	-0.5	–	$V_{DDP} + 0.5$ or max. 6	V	whichever is lower
Input current on any pin during overload condition	I_{IN} SR	-10	–	10	mA	–
Absolute maximum sum of all input currents during overload condition	ΣI_{IN} SR	-50	–	+50	mA	–

1) Excluding port pins P2.[1,2,6,7,8,9,11].

2) Applicable to port pins P2.[1,2,6,7,8,9,11].

3 Electrical Parameters

3.1.3 Pin Reliability in Overload

When receiving signals from higher voltage devices, low-voltage devices experience overload currents and voltages that go beyond their own IO power supplies specification.

Table 12 defines overload conditions that will not cause any negative reliability impact if all the following conditions are met:

- full operation life-time is not exceeded
- **Operating Conditions** are met for:
 - pad supply levels (V_{DDP})
 - temperature

If a pin current is outside of the **Operating Conditions** but within the overload conditions, then the parameters of this pin as stated in the Operating Conditions can no longer be guaranteed. Operation is still possible in most cases but with relaxed parameters.

Note: An overload condition on one or more pins does not require a reset.

Note: A series resistor at the pin to limit the current to the maximum permitted overload current is sufficient to handle failure situations like short to battery.

Table 12 Overload Parameters

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input current on any port pin during overload condition	I_{OV} SR	-5	–	5	mA	
Absolute sum of all input circuit currents during overload condition	I_{OVS} SR	–	–	25	mA	

Figure 10 shows the path of the input currents during overload via the ESD protection structures. The diodes against V_{DDP} and ground are a simplified representation of these ESD protection structures.

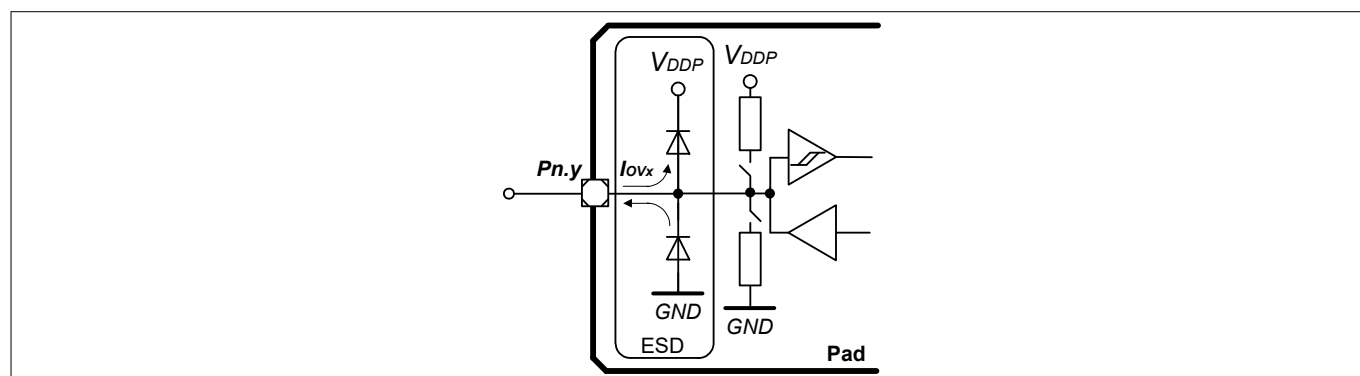


Figure 10 Input Overload Current via ESD structures

3 Electrical Parameters

Table 13 and Table 14 list input voltages that can be reached under overload conditions. Note that the absolute maximum input voltages as defined in the [Absolute Maximum Ratings](#) must not be exceeded during overload.

Table 13 PN-Junction Characteristics for positive Overload

Pad Type	$I_{OV} = 5 \text{ mA}$
Standard, High-current, AN/DIG_IN	$V_{IN} = V_{DDP} + 0.5 \text{ V}$ $V_{AIN} = V_{DDP} + 0.5 \text{ V}$ $V_{AREF} = V_{DDP} + 0.5 \text{ V}$
P2.[1,2,6;9,11]	$V_{INP2} = V_{DDP} + 0.3 \text{ V}$

Table 14 PN-Junction Characteristics for negative Overload

Pad Type	$I_{OV} = 5 \text{ mA}$
Standard, High-current, AN/DIG_IN	$V_{IN} = V_{SS} - 0.5 \text{ V}$ $V_{AIN} = V_{SS} - 0.5 \text{ V}$ $V_{AREF} = V_{SS} - 0.5 \text{ V}$
P2.[1,2,6;9,11]	$V_{INP2} = V_{SS} - 0.3 \text{ V}$

3.1.4 Operating Conditions

The following operating conditions must not be exceeded in order to ensure correct operation and reliability of the XMC1300. All parameters specified in the following tables refer to these operating conditions, unless noted otherwise.

Table 15 Operating Conditions Parameters

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Ambient Temperature	T_A SR	-40	–	85	°C	Temp. Range F
		-40	–	105	°C	Temp. Range X
Digital supply voltage ¹⁾	V_{DDP} SR	1.8	–	5.5	V	
MCLK Frequency	f_{MCLK} CC	–	–	33.2	MHz	CPU clock
PCLK Frequency	f_{PCLK} CC	–	–	66.4	MHz	Peripherals clock
Short circuit current of digital outputs	I_{SC} SR	-5	–	5	mA	
Absolute sum of short circuit currents of the device	ΣI_{SC_D} SR	–	–	25	mA	

1) See also the Supply Monitoring thresholds, [Chapter 3.3.2](#).

3 Electrical Parameters

3.2 DC Parameters

3.2.1 Input/Output Characteristics

Table 16 provides the characteristics of the input/output pins of the XMC1300.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Note: Unless otherwise stated, input DC and AC characteristics, including peripheral timings, assume that the input pads operate with the standard hysteresis.

Table 16 Input/Output Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit Values		Unit	Note/Test Condition
		Min.	Max.		
Output low voltage on port pins (with standard pads)	$V_{OLP\ CC}$	–	1.0	V	$I_{OL} = 11\text{ mA}$ (5 V) $I_{OL} = 7\text{ mA}$ (3.3 V)
		–	0.4	V	$I_{OL} = 5\text{ mA}$ (5 V) $I_{OL} = 3.5\text{ mA}$ (3.3 V)
Output low voltage on high current pads	$V_{OLP1\ CC}$	–	1.0	V	$I_{OL} = 50\text{ mA}$ (5 V) $I_{OL} = 25\text{ mA}$ (3.3 V)
		–	0.32	V	$I_{OL} = 10\text{ mA}$ (5 V)
		–	0.4	V	$I_{OL} = 5\text{ mA}$ (3.3 V)
Output high voltage on port pins (with standard pads)	$V_{OHP\ CC}$	$V_{DDP} - 1.0$	–	V	$I_{OH} = -10\text{ mA}$ (5 V) $I_{OH} = -7\text{ mA}$ (3.3 V)
		$V_{DDP} - 0.4$	–	V	$I_{OH} = -4.5\text{ mA}$ (5 V) $I_{OH} = -2.5\text{ mA}$ (3.3 V)
Output high voltage on high current pads	$V_{OHP1\ CC}$	$V_{DDP} - 0.32$	–	V	$I_{OH} = -6\text{ mA}$ (5 V)
		$V_{DDP} - 1.0$	–	V	$I_{OH} = -8\text{ mA}$ (3.3 V)
		$V_{DDP} - 0.4$	–	V	$I_{OH} = -4\text{ mA}$ (3.3 V)
Input low voltage on port pins (Standard Hysteresis)	$V_{ILPS\ SR}$	–	$0.19 \times V_{DDP}$	V	CMOS Mode (5 V, 3.3 V & 2.2 V)
Input high voltage on port pins (Standard Hysteresis)	$V_{IHPS\ SR}$	$0.7 \times V_{DDP}$	–	V	CMOS Mode (5 V, 3.3 V & 2.2 V)
Input low voltage on port pins (Large Hysteresis)	$V_{ILPL\ SR}$	–	$0.08 \times V_{DDP}$	V	CMOS Mode (5 V, 3.3 V & 2.2 V) ¹⁰⁾
Input high voltage on port pins (Large Hysteresis)	$V_{IHPL\ SR}$	$0.85 \times V_{DDP}$	–	V	CMOS Mode (5 V, 3.3 V & 2.2 V) ¹⁰⁾
Rise time on High Current Pad ¹⁾	$t_{HCPR\ CC}$	–	9	ns	50 pF @ 5 V ²⁾
		–	12	ns	50 pF @ 3.3 V ³⁾
		–	25	ns	50 pF @ 1.8 V ⁴⁾

(table continues...)

3 Electrical Parameters

Table 16 (continued) **Input/Output Characteristics (Operating Conditions apply)**

Parameter	Symbol	Limit Values		Unit	Note/Test Condition
		Min.	Max.		
Fall time on High Current Pad ¹⁾	t_{HCPF} CC	–	9	ns	50 pF @ 5 V ²⁾
		–	12	ns	50 pF @ 3.3 V ³⁾
		–	25	ns	50 pF @ 1.8 V ⁴⁾
Rise time on Standard Pad ¹⁾	t_R CC	–	12	ns	50 pF @ 5 V ⁵⁾
		–	15	ns	50 pF @ 3.3 V ⁶⁾
		–	31	ns	50 pF @ 1.8 V ⁷⁾
Fall time on Standard Pad ¹⁾	t_F CC	–	12	ns	50 pF @ 5 V ⁵⁾
		–	15	ns	50 pF @ 3.3 V ⁶⁾
		–	31	ns	50 pF @ 1.8 V ⁷⁾
Input Hysteresis ⁸⁾	HYS CC	$0.08 \times V_{DDP}$	–	V	CMOS Mode (5 V), Standard Hysteresis
		$0.03 \times V_{DDP}$	–	V	CMOS Mode (3.3 V), Standard Hysteresis
		$0.02 \times V_{DDP}$	–	V	CMOS Mode (2.2 V), Standard Hysteresis
		$0.5 \times V_{DDP}$	$0.75 \times V_{DDP}$	V	CMOS Mode(5 V), Large Hysteresis
		$0.4 \times V_{DDP}$	$0.75 \times V_{DDP}$	V	CMOS Mode(3.3 V), Large Hysteresis
		$0.2 \times V_{DDP}$	$0.65 \times V_{DDP}$	V	CMOS Mode(2.2 V), Large Hysteresis
Pin capacitance (digital inputs/outputs)	C_{IO} CC	–	10	pF	
Pull-up resistor on port pins	R_{PUP} CC	20	50	kohm	$V_{IN} = V_{SSP}$
Pull-down resistor on port pins	R_{PDP} CC	20	50	kohm	$V_{IN} = V_{DDP}$
Input leakage current ⁹⁾	I_{OZP} CC	-1	1	μA	$0 < V_{IN} < V_{DDP}$, $T_A \leq 105^\circ\text{C}$
Voltage on any pin during V_{DDP} power off	V_{PO} SR	–	0.3	V	¹⁰⁾
Maximum current per pin (excluding P1, V_{DDP} and V_{SS})	I_{MP} SR	-10	11	mA	–
Maximum current per high current pins	I_{MP1A} SR	-10	50	mA	–
Maximum current into V_{DDP} (TSSOP16, VQFN24)	I_{MVDD1} SR	–	130	mA	¹⁰⁾

(table continues...)

3 Electrical Parameters

Table 16 (continued) **Input/Output Characteristics (Operating Conditions apply)**

Parameter	Symbol	Limit Values		Unit	Note/Test Condition
		Min.	Max.		
Maximum current into V_{DDP} (TSSOP38, VQFN40)	I_{MVDD2} SR	–	260	mA	10)
Maximum current out of V_{SS} (TSSOP16, VQFN24)	I_{MVSS1} SR	–	130	mA	10)
Maximum current out of V_{SS} (TSSOP38, VQFN40)	I_{MVSS2} SR	–	260	mA	10)

- 1) Rise/Fall time parameters are taken with 10% - 90% of supply.
2) Additional rise/fall time valid for $C_L = 50$ pF - $C_L = 100$ pF @ 0.150 ns/pF at 5 V supply voltage.
3) Additional rise/fall time valid for $C_L = 50$ pF - $C_L = 100$ pF @ 0.205 ns/pF at 3.3 V supply voltage.
4) Additional rise/fall time valid for $C_L = 50$ pF - $C_L = 100$ pF @ 0.445 ns/pF at 1.8 V supply voltage.
5) Additional rise/fall time valid for $C_L = 50$ pF - $C_L = 100$ pF @ 0.225 ns/pF at 5 V supply voltage.
6) Additional rise/fall time valid for $C_L = 50$ pF - $C_L = 100$ pF @ 0.288 ns/pF at 3.3 V supply voltage.
7) Additional rise/fall time valid for $C_L = 50$ pF - $C_L = 100$ pF @ 0.588 ns/pF at 1.8 V supply voltage.
8) Hysteresis is implemented to avoid meta stable states and switching due to internal ground bounce. It cannot be guaranteed that it suppresses switching due to external system noise.
9) An additional error current (I_{INJ}) will flow if an overload current flows through an adjacent pin.
10) However, for applications with strict low power-down current requirements, it is mandatory that no active voltage source is supplied at any GPIO pin when V_{DDP} is powered off.

3.2.2 Analog to Digital Converters (ADC)

Table 17 shows the Analog to Digital Converter (ADC) characteristics.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 17 **ADC Characteristics (Operating Conditions apply)¹⁾**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Supply voltage range (internal reference)	V_{DD_int} SR	2.0	–	3.0	V	SHSCFG.AREF = 11 _B CALCTR.CALGNSTC = 0C _H
		3.0	–	5.5	V	SHSCFG.AREF = 10 _B
Supply voltage range (external reference)	V_{DD_ext} SR	3.0	–	5.5	V	SHSCFG.AREF = 00 _B
Analog input voltage range	V_{AIN} SR	$V_{SSP} - 0.05$	–	$V_{DDP} + 0.05$	V	
Auxiliary analog reference ground	V_{REFGND} SR	$V_{SSP} - 0.05$	–	1.0	V	G0CH0
		$V_{SSP} - 0.05$	–	0.2	V	G1CH0
Internal reference voltage (full scale value)	V_{REFINT} CC	5			V	

(table continues...)

3 Electrical Parameters

Table 17 (continued) ADC Characteristics (Operating Conditions apply)¹⁾

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Switched capacitance of an analog input	C_{AINS} CC	–	1.2	2	pF	GNCTRxz.GAINy = 00 _B (unity gain)
		–	1.2	2	pF	GNCTRxz.GAINy = 01 _B (gain g1)
		–	4.5	6	pF	GNCTRxz.GAINy = 10 _B (gain g2)
		–	4.5	6	pF	GNCTRxz.GAINy = 11 _B (gain g3)
Total capacitance of an analog input	C_{AINT} CC	–	–	10	pF	
Total capacitance of the reference input	C_{AREFT} CC	–	–	10	pF	
Gain settings	G_{IN} CC	1			–	GNCTRxz.GAINy = 00 _B (unity gain)
		3			–	GNCTRxz.GAINy = 01 _B (gain g1)
		6			–	GNCTRxz.GAINy = 10 _B (gain g2)
		12			–	GNCTRxz.GAINy = 11 _B (gain g3)
Sample Time	t_{sample} CC	3	–	–	$1/f_{ADC}$	$V_{DD} = 5.0\text{ V}$
		3	–	–	$1/f_{ADC}$	$V_{DD} = 3.3\text{ V}$
		30	–	–	$1/f_{ADC}$	$V_{DD} = 2.0\text{ V}$
Sigma delta loop hold time	t_{SD_hold} CC	20	–	–	μs	Residual charge stored in an active sigma delta loop remains available
Conversion time in fast compare mode	t_{CF} CC	9			$1/f_{ADC}$	²⁾
Conversion time in 12-bit mode	t_{C12} CC	20			$1/f_{ADC}$	²⁾
Maximum sample rate in 12-bit mode ³⁾	f_{C12} CC	–	–	$f_{ADC}/42.5$	–	1 sample pending
		–	–	$f_{ADC}/62.5$	–	2 samples pending
Conversion time in 10-bit mode	t_{C10} CC	18			$1/f_{ADC}$	²⁾

(table continues...)

3 Electrical Parameters

Table 17 (continued) ADC Characteristics (Operating Conditions apply)¹⁾

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Maximum sample rate in 10-bit mode ³⁾	f_{C10} CC	–	–	$f_{ADC}/40.5$	–	1 sample pending
		–	–	$f_{ADC}/58.5$	–	2 samples pending
Conversion time in 8-bit mode	t_{C8} CC	16			$1/f_{ADC}$	²⁾
Maximum sample rate in 8-bit mode ³⁾	f_{C8} CC	–	–	$f_{ADC}/38.5$	–	1 sample pending
		–	–	$f_{ADC}/54.5$	–	2 samples pending
RMS noise ⁴⁾	EN_{RMS} CC	–	1.5	–	LSB12	DC input, $V_{DD} = 5.0$ V, $V_{AIN} = 2.5$ V, 25°C
DNL error	EA_{DNL} CC	–	±2.0	–	LSB12	
INL error	EA_{INL} CC	–	±4.0	–	LSB12	
Gain error with external reference	EA_{GAIN} CC	–	±0.5	–	%	SHSCFG.AREF = 00 _B (calibrated)
Gain error with internal reference ⁵⁾	EA_{GAIN} CC	–	±3.6	–	%	SHSCFG.AREF = 1X _B (calibrated), -40°C - 105°C
		–	±2.0	–	%	SHSCFG.AREF = 1X _B (calibrated), 0°C - 85°C
Offset error	EA_{OFF} CC	–	±8.0	–	mV	Calibrated, $V_{DD} = 5.0$ V

- 1) The parameters are defined for ADC clock frequency $f_{SH} = 32$ MHz, SHSCFG.DIVS = 0000_B. Usage of any other frequencies may affect the ADC performance.
- 2) No pending samples assumed, excluding sampling time and calibration.
- 3) Includes synchronization and calibration (average of gain and offset calibration).
- 4) This parameter can also be defined as an SNR value: $SNR[dB] = 20 \times \log(A_{MAXeff}/N_{RMS})$. With $A_{MAXeff} = 2^N/2$, $SNR[dB] = 20 \times \log(2048/N_{RMS})$ [N = 12]. $N_{RMS} = 1.5$ LSB12, therefore, equals $SNR = 20 \times \log(2048/1.5) = 62.7$ dB.
- 5) Includes error from the reference voltage.

MC_VADC_AREFPATHS

3 Electrical Parameters

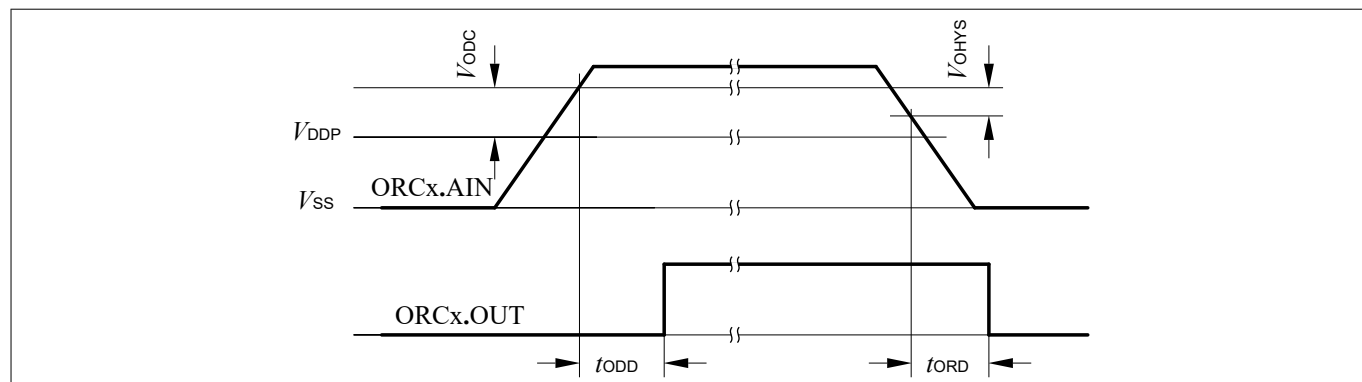


Figure 12 ORCx.OUT Trigger Generation

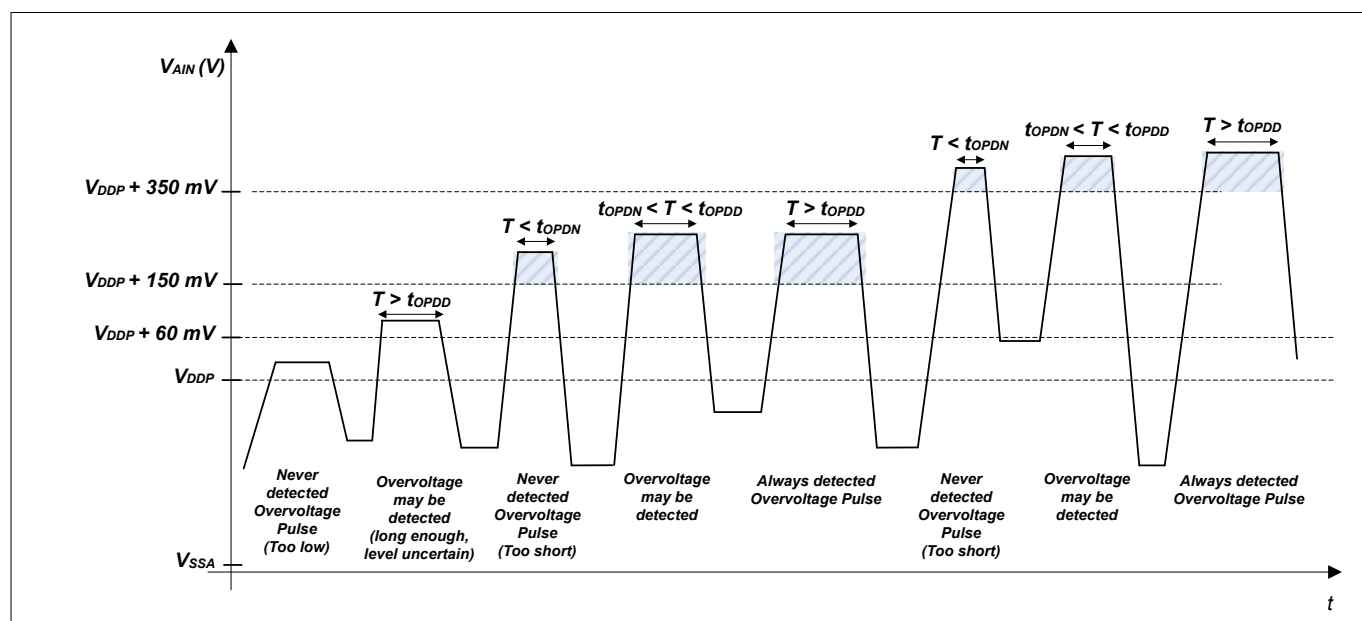


Figure 13 ORC Detection Ranges

3 Electrical Parameters

3.2.4 Analog Comparator Characteristics

Table 19 below shows the Analog Comparator characteristics.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 19 Analog Comparator Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input Voltage	$V_{\text{CMP SR}}$	-0.05	–	$V_{\text{DDP}} + 0.05$	V	
Input Offset	$V_{\text{CMPOFF CC}}$	–	+/-3	–	mV	High power mode $\Delta V_{\text{CMP}} < 200 \text{ mV}$
		–	+/-20	–	mV	Low power mode $\Delta V_{\text{CMP}} < 200 \text{ mV}$
Propagation Delay ¹⁾	$t_{\text{PDELAY CC}}$	–	25	–	ns	High power mode, $\Delta V_{\text{CMP}} = 100 \text{ mV}$
		–	80	–	ns	High power mode, $\Delta V_{\text{CMP}} = 25 \text{ mV}$
		–	250	–	ns	Low power mode, $\Delta V_{\text{CMP}} = 100 \text{ mV}$
		–	700	–	ns	Low power mode, $\Delta V_{\text{CMP}} = 25 \text{ mV}$
Current Consumption	$I_{\text{ACMP CC}}$	–	100	–	μA	First active ACMP in high power mode, $\Delta V_{\text{CMP}} > 30 \text{ mV}$
		–	66	–	μA	Each additional ACMP in high power mode, $\Delta V_{\text{CMP}} > 30 \text{ mV}$
		–	10	–	μA	First active ACMP in low power mode
		–	6	–	μA	Each additional ACMP in low power mode
Input Hysteresis	$V_{\text{HYS CC}}$	–	+/-15	–	mV	
Filter Delay ¹⁾	$t_{\text{FDELAY CC}}$	–	5	–	ns	

1) Total Analog Comparator Delay is the sum of Propagation Delay and Filter Delay.

3 Electrical Parameters

3.2.5 Temperature Sensor Characteristics

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 20 Temperature Sensor Characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Measurement time	t_M CC	–	–	10	ms	
Temperature sensor range	T_{SR} SR	-40	–	115	°C	
Sensor Accuracy ¹⁾	T_{TSAL} CC	-6	–	6	°C	$T_J > 20^\circ\text{C}$
		-10	–	10	°C	$0^\circ\text{C} \leq T_J \leq 20^\circ\text{C}$
		–	-/+8	–	°C	$T_J < 0^\circ\text{C}$
Start-up time after enabling	t_{TSSTE} SR	–	–	15	µs	

1) The temperature sensor accuracy is independent of the supply voltage.

3.2.6 Power Supply Current

The total power supply current defined below consists of a leakage and a switching component.

Application relevant values are typically lower than those given in the following tables, and depend on the customer's system operating conditions (e.g. thermal connection or used application configurations).

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 21 Power Supply Parameters; $V_{DDP} = 5\text{ V}$

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ. ¹⁾	Max.		
Active mode current Peripherals enabled f_{MCLK}/f_{PCLK} in MHz ²⁾	I_{DDPAE} CC	–	9.2	12	mA	32/64
		–	8.1	–	mA	24/48
		–	6.6	–	mA	16/32
		–	5.5	–	mA	8/16
		–	4	–	mA	1/1
Active mode current Peripherals disabled f_{MCLK}/f_{PCLK} in MHz ³⁾	I_{DDPAD} CC	–	4.8	–	mA	32/64
		–	4.1	–	mA	24/48
		–	3.3	–	mA	16/32
		–	2.7	–	mA	8/16
		–	1.5	–	mA	1/1
Active mode current Code execution from RAM Flash is powered down	I_{DDPAR} CC	–	7.3	–	mA	32/64
		–	6.3	–	mA	24/48
		–	5.2	–	mA	16/32

(table continues...)

3 Electrical Parameters

Table 21 (continued) Power Supply Parameters; $V_{DDP} = 5\text{ V}$

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ. ¹⁾	Max.		
f_{MCLK}/f_{PCLK} in MHz		–	4.2	–	mA	8/16
		–	3.3	–	mA	1/1
Sleep mode current Peripherals clock enabled f_{MCLK}/f_{PCLK} in MHz ⁴⁾	I_{DDPSE} CC	–	6.6	–	mA	32/64
			5.8	–	mA	24/48
			5.1	–	mA	16/32
			4.4	–	mA	8/16
			3.7	–	mA	1/1
Sleep mode current Peripherals clock disabled Flash active f_{MCLK}/f_{PCLK} in MHz ⁵⁾	I_{DDPSD} CC	–	1.8	–	mA	32/64
			1.7	–	mA	24/48
			1.6	–	mA	16/32
			1.5	–	mA	8/16
			1.4	–	mA	1/1
Sleep mode current Peripherals clock disabled Flash powered down f_{MCLK}/f_{PCLK} in MHz ⁶⁾	I_{DDPSR} CC	–	1.2	–	mA	32/64
			1.1	–	mA	24/48
			1.0	–	mA	16/32
			0.8	–	mA	8/16
			0.7	–	mA	1/1
Deep Sleep mode current ⁷⁾	I_{DDPDS} CC	–	0.24	–	mA	
Wake-up time from Sleep to Active mode ⁸⁾	t_{SSA} CC	–	6	–	cycles	
Wake-up time from Deep Sleep to Active mode ⁹⁾	t_{DSA} CC	–	280	–	µsec	

1) The typical values are measured at $T_A = +25^\circ\text{C}$ and $V_{DDP} = 5\text{ V}$.

2) CPU and all peripherals clock enabled, Flash is in active mode.

3) CPU enabled, all peripherals clock disabled, Flash is in active mode.

4) CPU in sleep, all peripherals clock enabled and Flash is in active mode.

5) CPU in sleep, Flash is in active mode.

6) CPU in sleep, Flash is powered down and code executed from RAM after wake-up.

7) CPU in sleep, peripherals clock disabled, Flash is powered down and code executed from RAM after wake-up.

8) CPU in sleep, Flash is in active mode during sleep mode.

9) CPU in sleep, Flash is in powered down mode during deep sleep mode.

3 Electrical Parameters

Figure 14 shows typical graphs for active mode supply current for $V_{DDP} = 5\text{ V}$, $V_{DDP} = 3.3\text{ V}$, $V_{DDP} = 1.8\text{ V}$ across different clock frequencies.

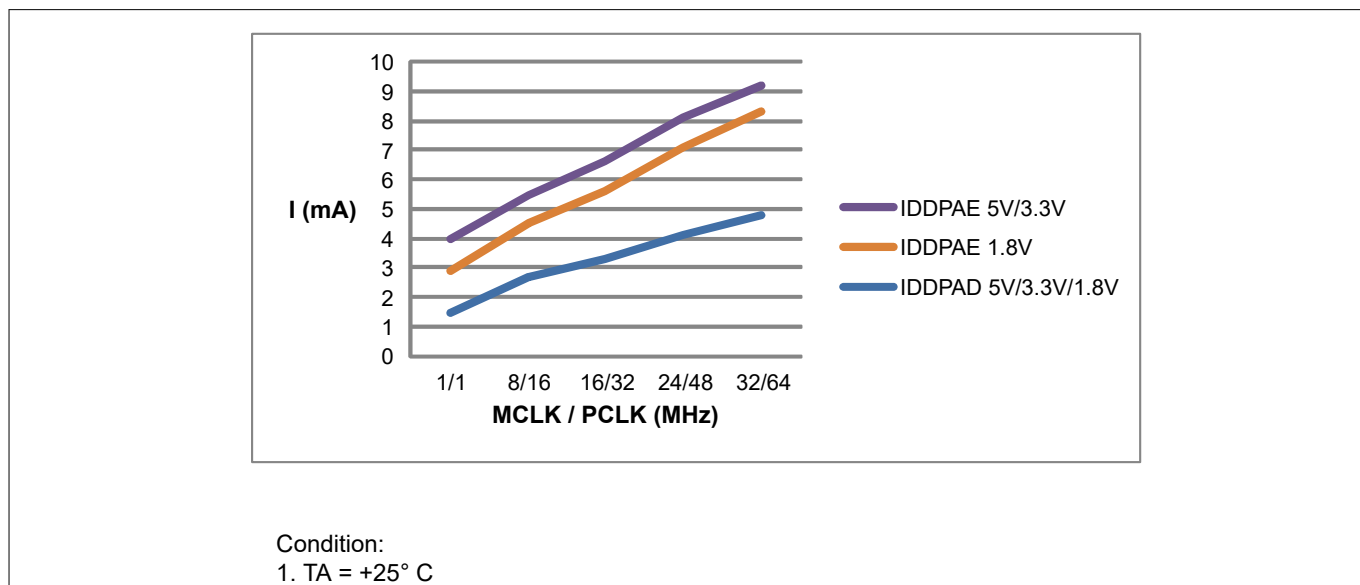


Figure 14 Active mode, a) peripherals clocks enabled, b) peripherals clocks disabled: Supply current I_{DDPA} over supply voltage V_{DDP} for different clock frequencies

Figure 15 shows typical graphs for sleep mode current for $V_{DDP} = 5\text{ V}$, $V_{DDP} = 3.3\text{ V}$, $V_{DDP} = 1.8\text{ V}$ across different clock frequencies.

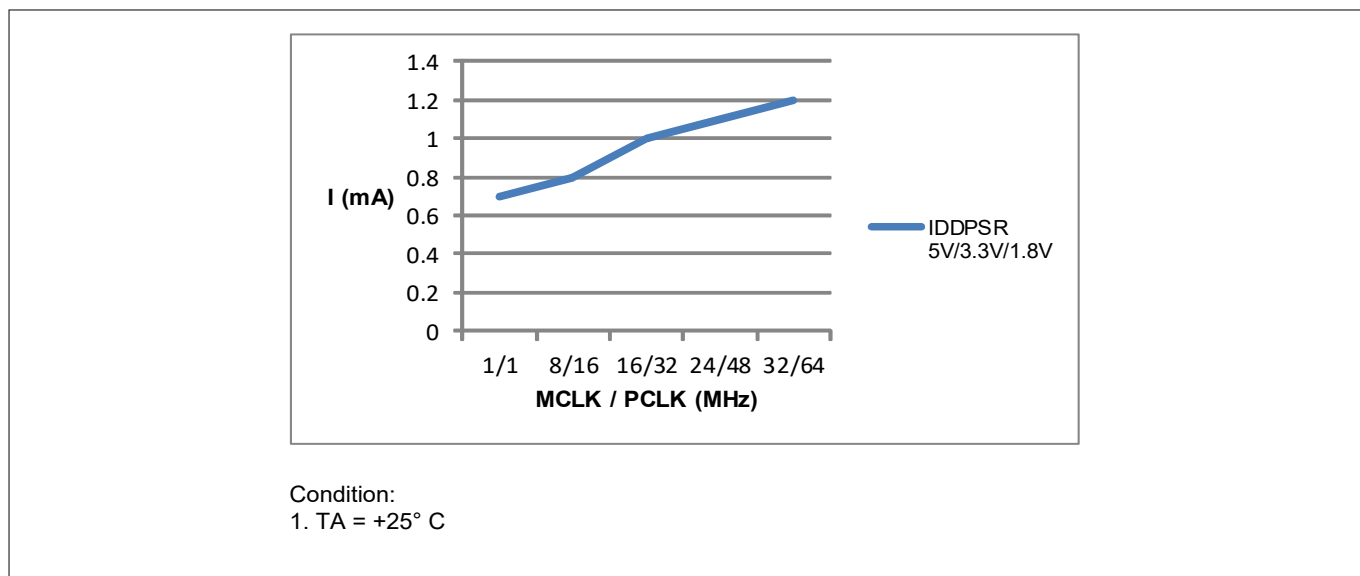


Figure 15 Sleep mode, peripherals clocks disabled, Flash powered down: Supply current I_{DDPSR} over supply voltage V_{DDP} for different clock frequencies

Table 22 provides the active current consumption of some modules operating at 5 V power supply at 25°C. The typical values shown are used as a reference guide on the current consumption when these modules are enabled.

3 Electrical Parameters

Table 22 Typical Active Current Consumption

Active Current Consumption	Symbol	Limit Values	Unit	Note/Test Condition
		Typ.		
Baseload current	I_{CPUDDC}	5.04	mA	Modules including Core, SCU, PORT, memories, ANATOP ¹⁾
VADC and SHS	I_{ADCDDC}	3.4	mA	Set CGATCLR0.VADC to 1 ²⁾
USIC0	$I_{USIC0DDC}$	0.87	mA	Set CGATCLR0.USIC0 to 1 ³⁾
CCU40	$I_{CCU40DDC}$	0.94	mA	Set CGATCLR0.CCU40 to 1 ⁴⁾
CCU80	$I_{CCU80DDC}$	0.42	mA	Set CGATCLR0.CCU80 to 1 ⁵⁾
POSIF0	$I_{PIF0DDC}$	0.26	mA	Set CGATCLR0.POSIF0 to 1 ⁶⁾
BCCU0	$I_{BCCU0DDC}$	0.24	mA	Set CGATCLR0.BCCU0 to 1 ⁷⁾
MATH	$I_{MATHDDC}$	0.35	mA	Set CGATCLR0.MATH to 1 ⁸⁾
WDT	I_{WDTDDC}	0.03	mA	Set CGATCLR0.WDT to 1 ⁹⁾
RTC	I_{RTCDDC}	0.01	mA	Set CGATCLR0.RTC to 1 ¹⁰⁾

- 1) Baseload current is measured with device running in user mode, MCLK=PCLK=32 MHz, with an endless loop in the flash memory. The clock to the modules stated in CGATSTAT0 are gated.
- 2) Active current is measured with: module enabled, MCLK=32 MHz, running in auto-scan conversion mode.
- 3) Active current is measured with: module enabled, alternating messages sent to PC at 57.6 kbaud every 200 ms.
- 4) Active current is measured with: module enabled, MCLK=PCLK=32 MHz, 1 CCU4 slice for PWM switching from 1500 Hz and 1000 Hz at regular intervals, 1 CCU4 slice in capture mode for reading period and duty cycle.
- 5) Active current is measured with: module enabled, MCLK=PCLK=32 MHz, 1 CCU8 slice with PWM frequency at 1500 Hz and a period match interrupt used to toggle duty cycle between 10% and 90%.
- 6) Active current is measured with: module enabled, MCLK=32 MHz, PCLK=64 MHz, hall sensor mode.
- 7) Active current is measured with: module enabled, MCLK=32 MHz, PCLK=64 MHz, FCLK=0.8 MHz, Normal mode (BCCU Clk = FCLK/4), 3 BCCU Channels and 1 Dimming Engine, change color or dim every 1 s.
- 8) Active current is measured with: module enabled, MCLK=32 MHz, PCLK=64 MHz, tangent calculation in while loop; CORDIC circular rotation, no keep, autostart; 32-by-32 bit signed DIV, autostart, DVS right shift by 11.
- 9) Active current is measured with: module enabled, MCLK=32 MHz, time-out mode; WLB = 0, WUB = 0x00008000; WDT serviced every 1 s.
- 10) Active current is measured with: module enabled, MCLK=32 MHz, Periodic interrupt enabled.

3.2.7 Flash Memory Parameters

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 23 Flash Memory Parameters

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Erase Time per page/sector	$t_{ERASE\ CC}$	6.8	7.1	7.6	ms	
Program time per block	$t_{PSER\ CC}$	102	152	204	μs	
Wake-Up time	$t_{WU\ CC}$	–	32.2	–	μs	
Read time per word	$t_a\ CC$	–	50	–	ns	

(table continues...)

3 Electrical Parameters

Table 23 (continued) **Flash Memory Parameters**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Data Retention Time	t_{RET} CC	10	–	–	years	Max. 100 erase/program cycles
Flash Wait States ¹⁾	N_{WSFLASH} CC	0	0	0		$f_{\text{MCLK}} = 8 \text{ MHz}$
		0	1	1		$f_{\text{MCLK}} = 16 \text{ MHz}$
		1	1.3	2		$f_{\text{MCLK}} = 32 \text{ MHz}$
Fixed Flash Wait States configured in bit NVM_NVMCONF.WS	N_{FWSFLASH} SR	0	0	1		NVM_CONFIG1.FIXWS = 1 _B , $f_{\text{MCLK}} \leq 16 \text{ MHz}$
		1	1	1		NVM_CONFIG1.FIXWS = 1 _B , $16 \text{ MHz} < f_{\text{MCLK}} \leq 32 \text{ MHz}$
Erase Cycles	N_{ECYC} CC	–	–	$5 \cdot 10^4$	cycles	Sum of page and sector erase cycles
Total Erase Cycles	N_{TECYC} CC	–	–	$2 \cdot 10^6$	cycles	

1) Flash wait states are automatically inserted by the Flash module during memory read when needed. Typical values are calculated from the execution of the Dhrystone benchmark program.

3.3 AC Parameters

3.3.1 Testing Waveforms

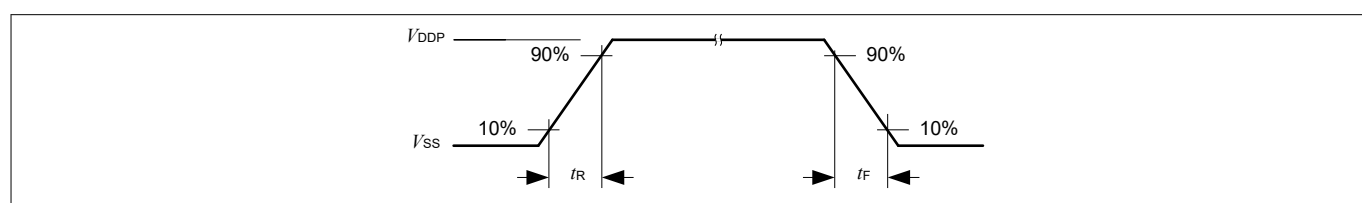


Figure 16 Rise/Fall Time Parameters

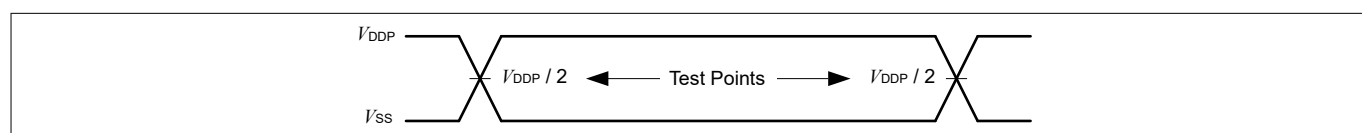


Figure 17 Testing Waveform, Output Delay

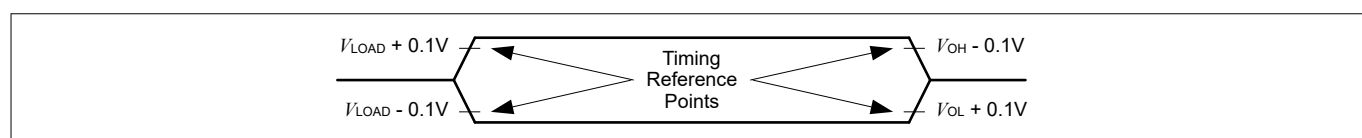


Figure 18 Testing Waveform, Output High Impedance

3 Electrical Parameters

3.3.2 Power-Up and Supply Monitoring Characteristics

Table 24 provides the characteristics of the power-up and supply monitoring in XMC1300.

The guard band between the lowest valid operating voltage and the brownout reset threshold provides a margin for noise immunity and hysteresis. The electrical parameters may be violated while V_{DDP} is outside its operating range.

The brownout detection triggers a reset within the defined range. The prewarning detection can be used to trigger an early warning and issue corrective and/or fail-safe actions in case of a critical supply voltage drop.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 24 Power-Up and Supply Monitoring Parameters (Operating Conditions apply)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
V_{DDP} ramp-up time	t_{RAMPUP} SR	$V_{DDP}/S_{VDDPrise}$	–	10^7	μs	
V_{DDP} slew rate	S_{VDDPOP} SR	0	–	0.1	V/ μs	Slope during normal operation
	S_{VDDP10} SR	0	–	10	V/ μs	Slope during fast transient within +/-10% of V_{DDP}
	$S_{VDDPrise}$ SR	0	–	10	V/ μs	Slope during power-on or restart after brownout event
	$S_{VDDPfall}$ ¹⁾ SR	0	–	0.25	V/ μs	Slope during supply falling out of the +/-10% limits ²⁾
V_{DDP} prewarning voltage	V_{DDPPW} CC	2.1	2.25	2.4	V	ANAVDEL.VDEL_SELECT = 00 _B
		2.85	3	3.15	V	ANAVDEL.VDEL_SELECT = 01 _B
		4.2	4.4	4.6	V	ANAVDEL.VDEL_SELECT = 10 _B
V_{DDP} brownout reset voltage	V_{DDPBO} CC	1.55	1.62	1.75	V	calibrated, before user code starts running
V_{DDP} voltage to ensure defined pad states	V_{DDPPA} CC	–	1.0	–	V	
Start-up time from power-on reset	t_{SSW} SR	–	320	–	μs	Time to the first user code instruction ³⁾
BMI program time	t_{BMI} SR	–	8.25	–	ms	Time taken from a user-triggered system reset after BMI installation is requested

1) A capacitor of at least 100 nF has to be added between V_{DDP} and V_{SSP} to fulfill the requirement as stated for this parameter.

2) Valid for a 100 nF buffer capacitor connected to supply pin where current from capacitor is forwarded only to the chip. A larger capacitor value has to be chosen if the power source sink a current.

3) This values does not include the ramp-up time. During start-up firmware execution, MCLK is running at 32 MHz and the clocks to peripheral as specified in register CGATSTAT0 are gated.

3 Electrical Parameters

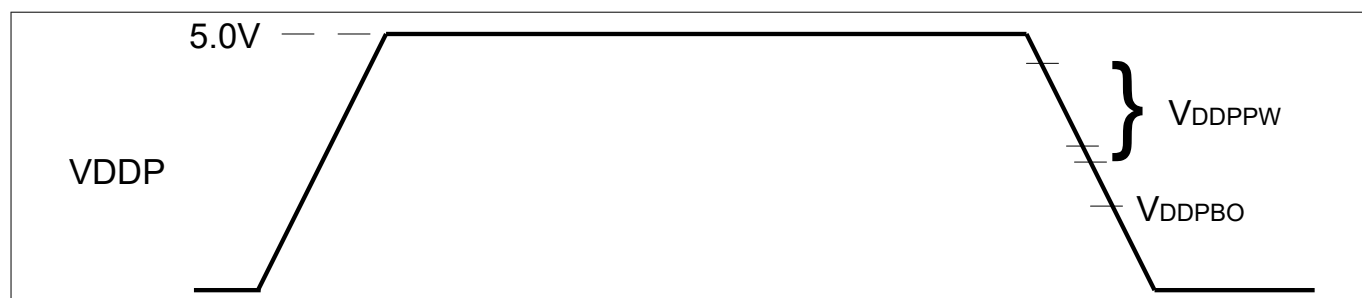


Figure 19 Supply Threshold Parameters

3.3.3 On-Chip Oscillator Characteristics

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 25 provides the characteristics of the 64 MHz clock output from the digital controlled oscillator, DCO1 in XMC1300.

Table 25 64 MHz DCO1 Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Nominal frequency	$f_{\text{NOM CC}}$	–	64	–	MHz	under nominal conditions ¹⁾ after trimming
Accuracy ²⁾	$\Delta f_{\text{LT CC}}$	-1.7	–	3.4	%	with respect to $f_{\text{NOM}}(\text{typ})$, over temperature ($T_A = 0^\circ\text{C}$ to 85°C)
		-3.9	–	4.0	%	with respect to $f_{\text{NOM}}(\text{typ})$, over temperature ($T_A = -40^\circ\text{C}$ to 105°C)

1) The deviation is relative to the factory trimmed frequency at nominal V_{DDC} and $T_A = +25^\circ\text{C}$.

2) The accuracy can be further improved through alternative methods, refer to XMC1000 Oscillator Handling Application Note.

Figure 20 shows the typical curves for the accuracy of DCO1, with and without calibration based on temperature sensor, respectively.

3 Electrical Parameters

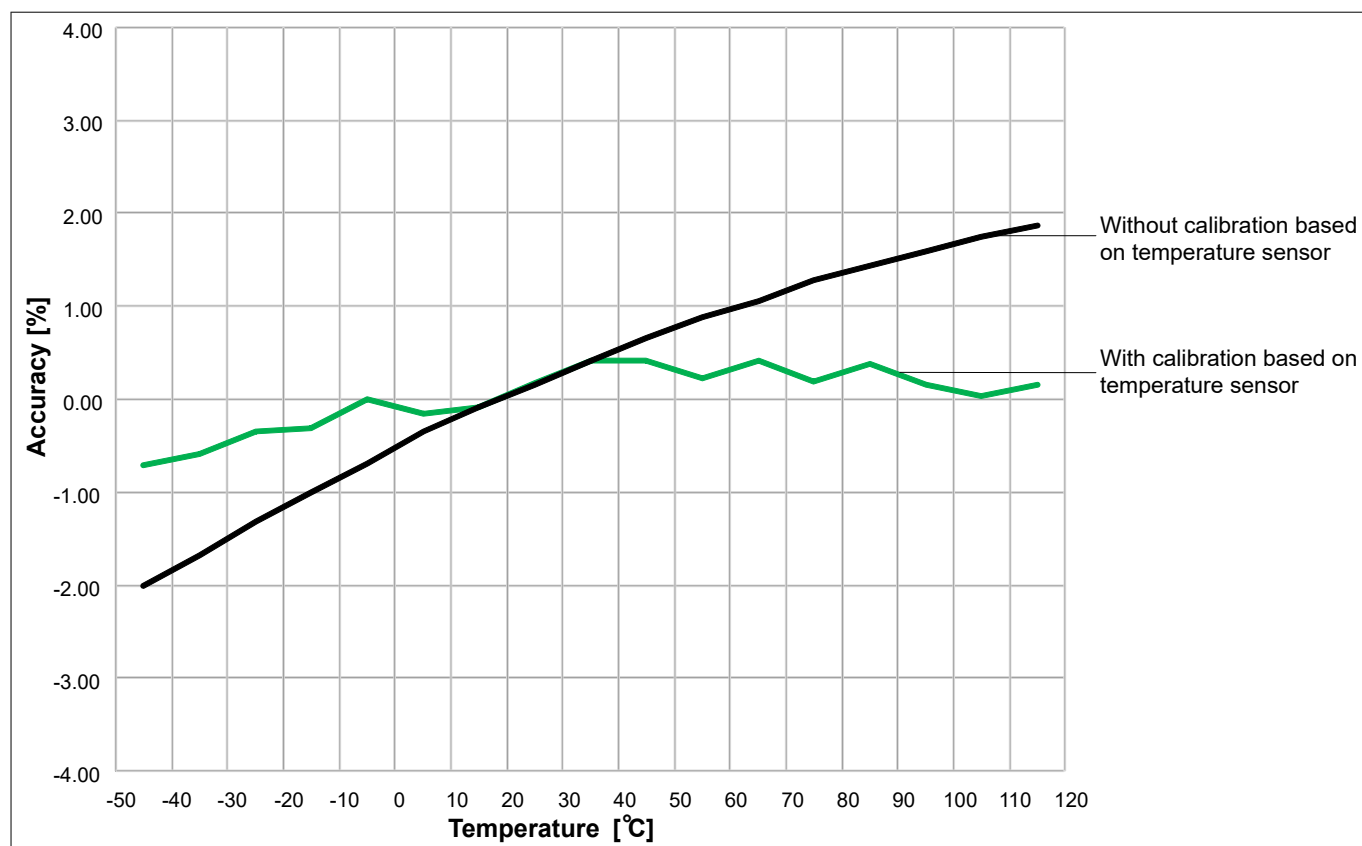


Figure 20 Typical DCO1 accuracy over temperature

Table 26 provides the characteristics of the 32 kHz clock output from digital controlled oscillators, DCO2 in XMC1300.

Table 26 32 kHz DCO2 Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Nominal frequency	$f_{\text{NOM CC}}$	–	32.75	–	kHz	under nominal conditions ¹⁾ after trimming
Accuracy	$\Delta f_{\text{LT CC}}$	-1.7	–	3.4	%	with respect to $f_{\text{NOM}}(\text{typ})$, over temperature (0°C to 85°C)
		-3.9	–	4.0	%	with respect to $f_{\text{NOM}}(\text{typ})$, over temperature (-40°C to 105°C)

1) The deviation is relative to the factory trimmed frequency at nominal V_{DDC} and $T_{\text{A}} = +25^{\circ}\text{C}$.

3 Electrical Parameters

3.3.4 Serial Wire Debug Port (SW-DP) Timing

The following parameters are applicable for communication through the SW-DP interface.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 27 SWD Interface Timing Parameters(Operating Conditions apply)

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
SWDCLK high time	t_1 SR	50	–	500000	ns	–
SWDCLK low time	t_2 SR	50	–	500000	ns	–
SWDIO input setup to SWDCLK rising edge	t_3 SR	10	–	–	ns	–
SWDIO input hold after SWDCLK rising edge	t_4 SR	10	–	–	ns	–
SWDIO output valid time after SWDCLK rising edge	t_5 CC	–	–	68	ns	$C_L = 50$ pF
		–	–	62	ns	$C_L = 30$ pF
SWDIO output hold time from SWDCLK rising edge	t_6 CC	4	–	–	ns	

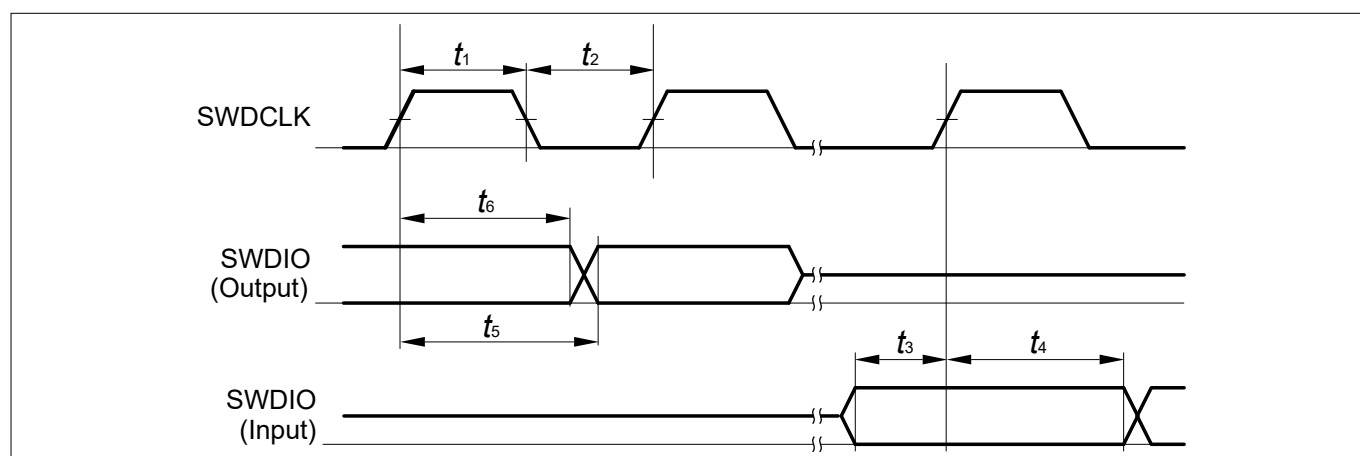


Figure 21 SWD Timing

3 Electrical Parameters

3.3.5 SPD Timing Requirements

The optimum SPD decision time between 0_B and 1_B is $0.75 \mu s$. With this value the system has maximum robustness against frequency deviations of the sampling clock on tool and on device side. However it is not always possible to exactly match this value with the given constraints for the sample clock. For instance for a oversampling rate of 4, the sample clock will be 8 MHz and in this case the closest possible effective decision time is 5.5 clock cycles ($0.69 \mu s$).

Table 28 Optimum Number of Sample Clocks for SPD

Sample Freq.	Sampling Factor	Sample Clocks 0_B	Sample Clocks 1_B	Effective Decision Time ¹⁾	Remark
8 MHz	4	1 to 5	6 to 12	$0.69 \mu s$	The other closest option ($0.81 \mu s$) for the effective decision time is less robust.

1) Nominal sample frequency period multiplied with $0.5 + (\text{max. number of } 0_B \text{ sample clocks})$.

For a balanced distribution of the timing robustness of SPD between tool and device, the timing requirements for the tool are:

- Frequency deviation of the sample clock is $\pm 5\%$
- Effective decision time is between $0.69 \mu s$ and $0.75 \mu s$ (calculated with nominal sample frequency)

3.3.6 Peripheral Timings

Note: These parameters are not subject to production test, but verified by design and/or characterization.

3.3.6.1 Synchronous Serial Interface (USIC SSC) Timing

The following parameters are applicable for a USIC channel operated in SSC mode.

Note: Operating Conditions apply.

Table 29 USIC SSC Master Mode Timing

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
SCLKOUT master clock period	$t_{CLK} CC$	62.5	–	–	ns	
Slave select output SELO active to first SCLKOUT transmit edge	$t_1 CC$	80	–	–	ns	
Slave select output SELO inactive after last SCLKOUT receive edge	$t_2 CC$	0	–	–	ns	
Data output DOUT[3:0] valid time	$t_3 CC$	-10	–	10	ns	
Receive data input DX0/DX[5:3] setup time to SCLKOUT receive edge	$t_4 SR$	80	–	–	ns	

(table continues...)

3 Electrical Parameters

Table 29 (continued) **USIC SSC Master Mode Timing**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Data input DX0/DX[5:3] hold time from SCLKOUT receive edge	t_5 SR	0	–	–	ns	

Table 30 **USIC SSC Slave Mode Timing**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
DX1 slave clock period	t_{CLK} SR	125	–	–	ns	
Select input DX2 setup to first clock input DX1 transmit edge ¹⁾	t_{10} SR	10	–	–	ns	
Select input DX2 hold after last clock input DX1 receive edge ¹⁾	t_{11} SR	10	–	–	ns	
Receive data input DX0/DX[5:3] setup time to shift clock receive edge ¹⁾	t_{12} SR	10	–	–	ns	
Data input DX0/DX[5:3] hold time from clock input DX1 receive edge ¹⁾	t_{13} SR	10	–	–	ns	
Data output DOUT[3:0] valid time	t_{14} CC	–	–	80	ns	

1) These input timings are valid for asynchronous input signal handling of slave select input, shift clock input, and receive data input (bits DXnCR.DSEN = 0).

3 Electrical Parameters

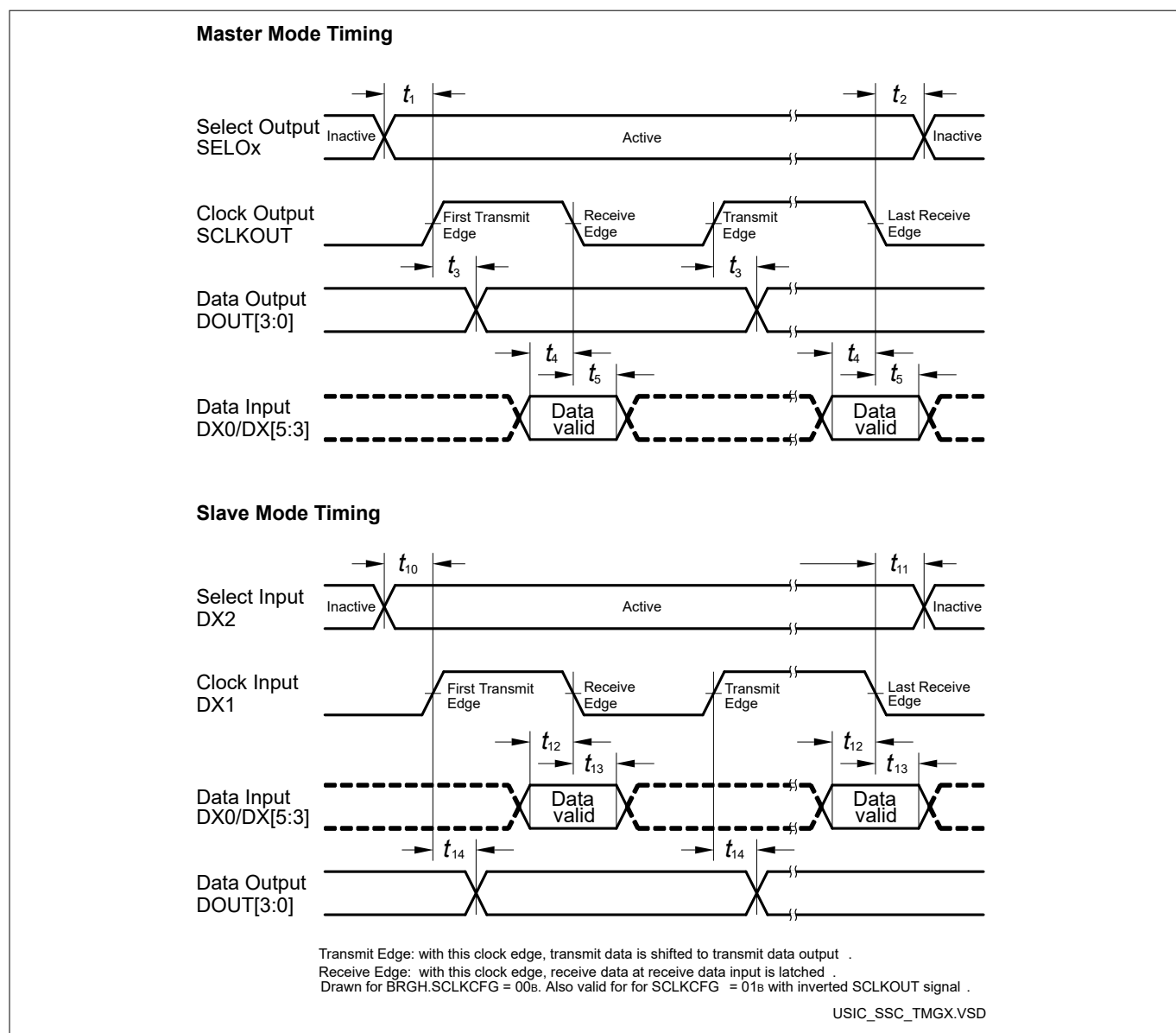


Figure 22 USIC - SSC Master/Slave Mode Timing

Note: This timing diagram shows a standard configuration, for which the slave select signal is low-active, and the serial clock signal is not shifted and not inverted.

3 Electrical Parameters

3.3.6.2 Inter-IC (IIC) Interface Timing

The following parameters are applicable for a USIC channel operated in IIC mode.

Note: Operating Conditions apply.

Table 31 USIC IIC Standard Mode Timing¹⁾

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Fall time of both SDA and SCL	t_1 CC/SR	–	–	300	ns	
Rise time of both SDA and SCL	t_2 CC/SR	–	–	1000	ns	
Data hold time	t_3 CC/SR	0	–	–	μs	
Data set-up time	t_4 CC/SR	250	–	–	ns	
LOW period of SCL clock	t_5 CC/SR	4.7	–	–	μs	
HIGH period of SCL clock	t_6 CC/SR	4.0	–	–	μs	
Hold time for (repeated) START condition	t_7 CC/SR	4.0	–	–	μs	
Set-up time for repeated START condition	t_8 CC/SR	4.7	–	–	μs	
Set-up time for STOP condition	t_9 CC/SR	4.0	–	–	μs	
Bus free time between a STOP and START condition	t_{10} CC/SR	4.7	–	–	μs	
Capacitive load for each bus line	C_b SR	–	–	400	pF	

1) Due to the wired-AND configuration of an IIC bus system, the port drivers of the SCL and SDA signal lines need to operate in open-drain mode. The high level on these lines must be held by an external pull-up device, approximately 10 kOhm for operation at 100 kbit/s, approximately 2 kOhm for operation at 400 kbit/s.

Table 32 USIC IIC Fast Mode Timing¹⁾

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Fall time of both SDA and SCL	t_1 CC/SR	$20 + 0.1 \cdot C_b$ ²⁾	–	300	ns	
Rise time of both SDA and SCL	t_2 CC/SR	$20 + 0.1 \cdot C_b$	–	300	ns	
Data hold time	t_3 CC/SR	0	–	–	μs	
Data set-up time	t_4 CC/SR	100	–	–	ns	
LOW period of SCL clock	t_5 CC/SR	1.3	–	–	μs	
HIGH period of SCL clock	t_6 CC/SR	0.6	–	–	μs	
Hold time for (repeated) START condition	t_7 CC/SR	0.6	–	–	μs	
Set-up time for repeated START condition	t_8 CC/SR	0.6	–	–	μs	
Set-up time for STOP condition	t_9 CC/SR	0.6	–	–	μs	

(table continues...)

3 Electrical Parameters

Table 32 (continued) **USIC IIC Fast Mode Timing¹⁾**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Bus free time between a STOP and START condition	t_{10} CC/SR	1.3	–	–	μs	
Capacitive load for each bus line	C_b SR	–	–	400	pF	

- 1) Due to the wired-AND configuration of an IIC bus system, the port drivers of the SCL and SDA signal lines need to operate in open-drain mode. The high level on these lines must be held by an external pull-up device, approximately 10 kOhm for operation at 100 kbit/s, approximately 2 kOhm for operation at 400 kbit/s.
- 2) C_b refers to the total capacitance of one bus line in pF.

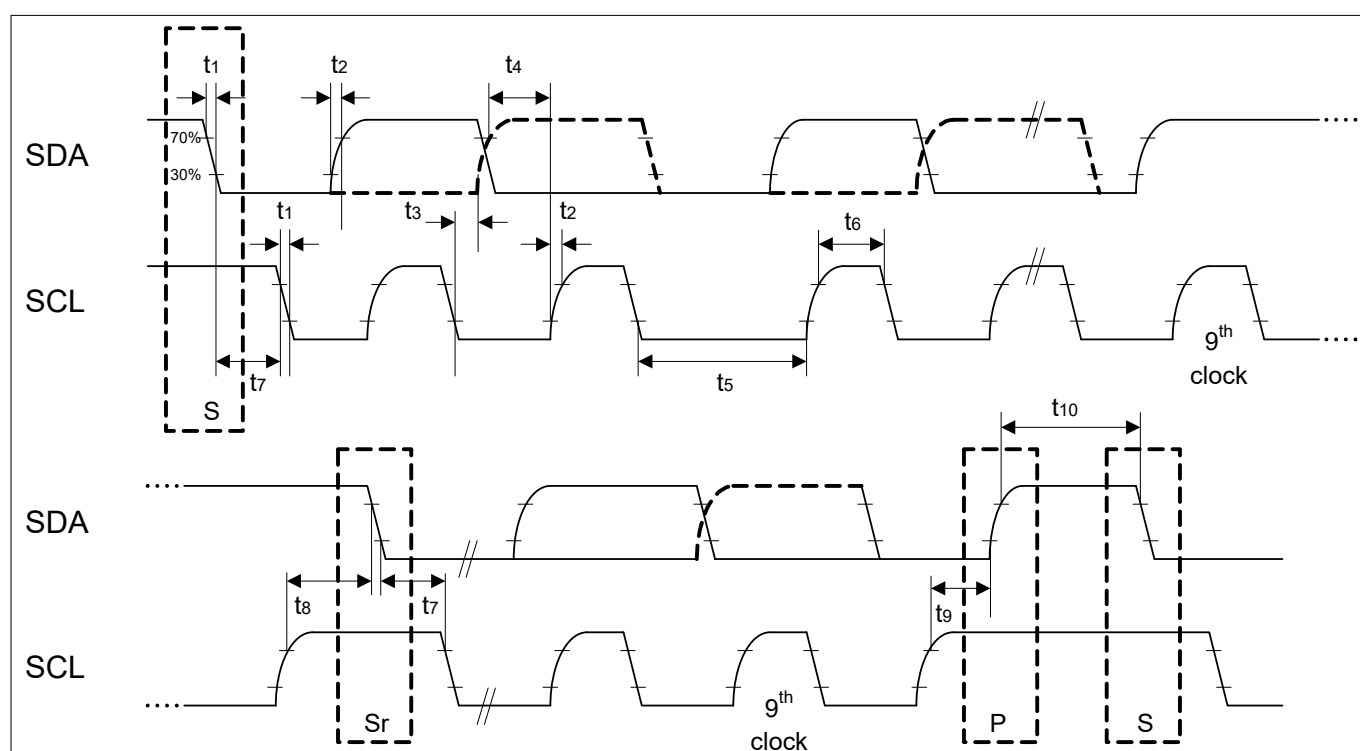


Figure 23 **USIC IIC Stand and Fast Mode Timing**

3 Electrical Parameters

3.3.6.3 Inter-IC Sound (IIS) Interface Timing

The following parameters are applicable for a USIC channel operated in IIS mode.

Note: *Operating Conditions apply.*

Table 33 USIC IIS Master Transmitter Timing

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Clock period	t_1 CC	$2/f_{\text{MCLK}}$	–	–	ns	$V_{\text{DDP}} \geq 3 \text{ V}$
		$4/f_{\text{MCLK}}$	–	–	ns	$V_{\text{DDP}} < 3 \text{ V}$
Clock HIGH	t_2 CC	$0.35 \times t_{1\text{min}}$	–	–	ns	
Clock Low	t_3 CC	$0.35 \times t_{1\text{min}}$	–	–	ns	
Hold time	t_4 CC	0	–	–	ns	
Clock rise time	t_5 CC	–	–	$0.15 \times t_{1\text{min}}$	ns	

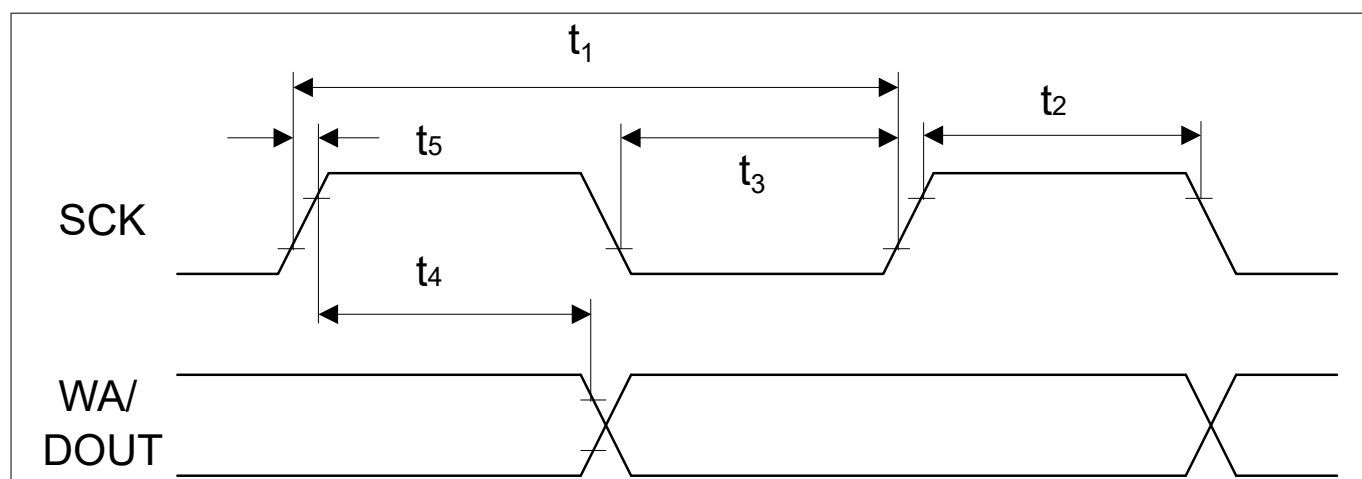


Figure 24 USIC IIS Master Transmitter Timing

3 Electrical Parameters

Table 34 USIC IIS Slave Receiver Timing

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Clock period	t_6 SR	$4/f_{MCLK}$	–	–	ns	
Clock HIGH	t_7 SR	$0.35 \times t_{6min}$	–	–	ns	
Clock Low	t_8 SR	$0.35 \times t_{6min}$	–	–	ns	
Set-up time	t_9 SR	$0.2 \times t_{6min}$	–	–	ns	
Hold time	t_{10} SR	10	–	–	ns	

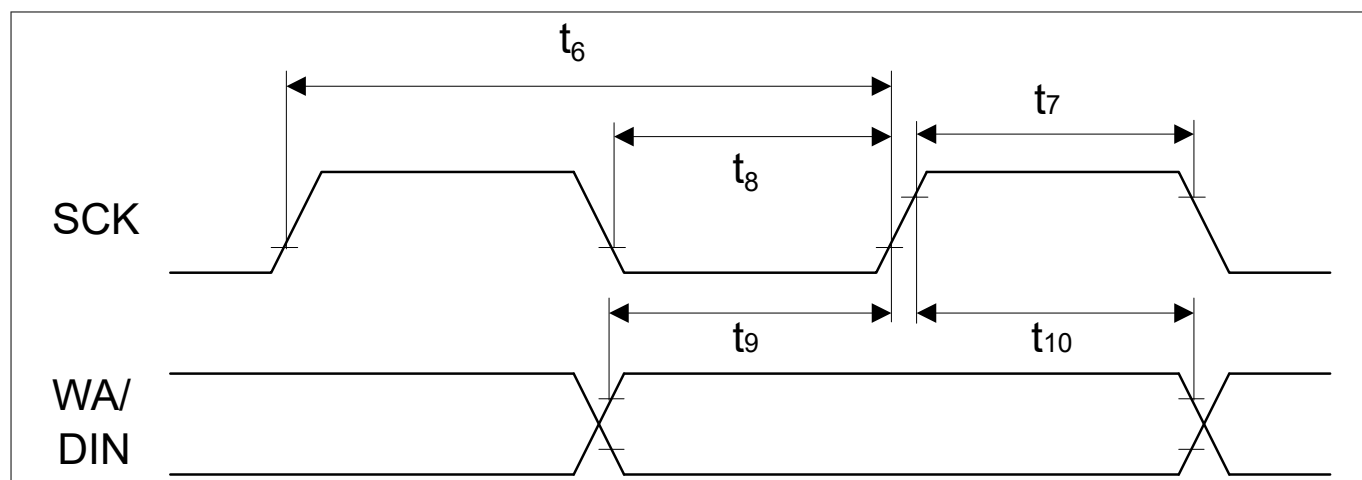


Figure 25 USIC IIS Slave Receiver Timing

4 Package and Reliability

4 Package and Reliability

The XMC1300 is a member of the XMC1000 Family of microcontrollers. It is also compatible to a certain extent with members of similar families or subfamilies.

Each package is optimized for the device it houses. Therefore, there may be slight differences between packages of the same pin-count but for different device types. In particular, the size of the exposed die pad may vary.

If different device types are considered or planned for an application, it must be ensured that the board layout fits all packages under consideration.

4.1 Package Parameters

Table 35 provides the thermal characteristics of the packages used in XMC1300.

Table 35 Thermal Characteristics of the Packages

Parameter	Symbol	Limit Values		Unit	Package Types
		Min.	Max.		
Exposed Die Pad Dimensions	Ex × Ey CC	–	2.7 × 2.7	mm	PG-VQFN-24-19
		–	3.7 × 3.7	mm	PG-VQFN-40-13
Thermal resistance Junction-Ambient	R _{ΘJA} CC	–	104.6	K/W	PG-TSSOP-16-8 ¹⁾
		–	83.2	K/W	PG-TSSOP-28-16 ¹⁾
		–	70.3	K/W	PG-TSSOP-38-9 ¹⁾
		–	46.0	K/W	PG-VQFN-24-19 ¹⁾
		–	38.4	K/W	PG-VQFN-40-13 ¹⁾

1) Device mounted on a 4-layer JEDEC board (JESD 51-5); exposed pad soldered.

Note: For electrical reasons, it is required to connect the exposed pad to the board ground V_{SSP} , independent of EMC and thermal requirements.

4.1.1 Thermal Considerations

When operating the XMC1300 in a system, the total heat generated in the chip must be dissipated to the ambient environment to prevent overheating and the resulting thermal damage.

The maximum heat that can be dissipated depends on the package and its integration into the target board. The “Thermal resistance $R_{\Theta JA}$ ” quantifies these parameters. The power dissipation must be limited so that the average junction temperature does not exceed 115°C.

The difference between junction temperature and ambient temperature is determined by

$$\Delta T = (P_{INT} + P_{IOSTAT} + P_{IODYN}) \times R_{\Theta JA}$$

The internal power consumption is defined as

$$P_{INT} = V_{DDP} \times I_{DDP} \text{ (switching current and leakage current).}$$

The static external power consumption caused by the output drivers is defined as

$$P_{IOSTAT} = \Sigma((V_{DDP} - V_{OH}) \times I_{OH}) + \Sigma(V_{OL} \times I_{OL})$$

The dynamic external power consumption caused by the output drivers (P_{IODYN}) depends on the capacitive load connected to the respective pins and their switching frequencies.

4 Package and Reliability

If the total power dissipation for a given system configuration exceeds the defined limit, countermeasures must be taken to ensure proper system operation:

- Reduce V_{DDP} , if possible in the system
- Reduce the system frequency
- Reduce the number of output pins
- Reduce the load on active output drivers

4.2 Package Outlines

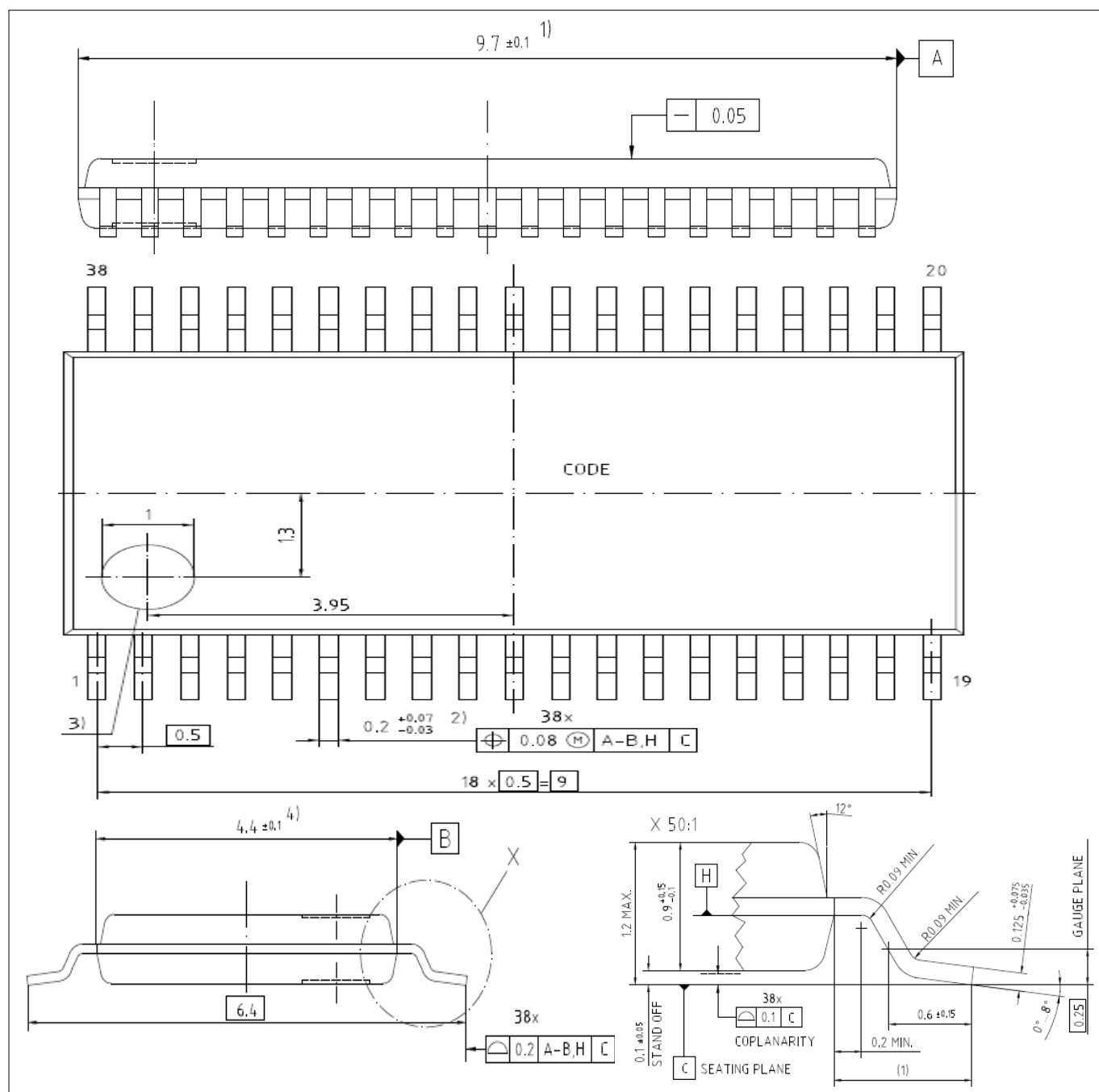


Figure 26 PG-TSSOP-38-9

4 Package and Reliability

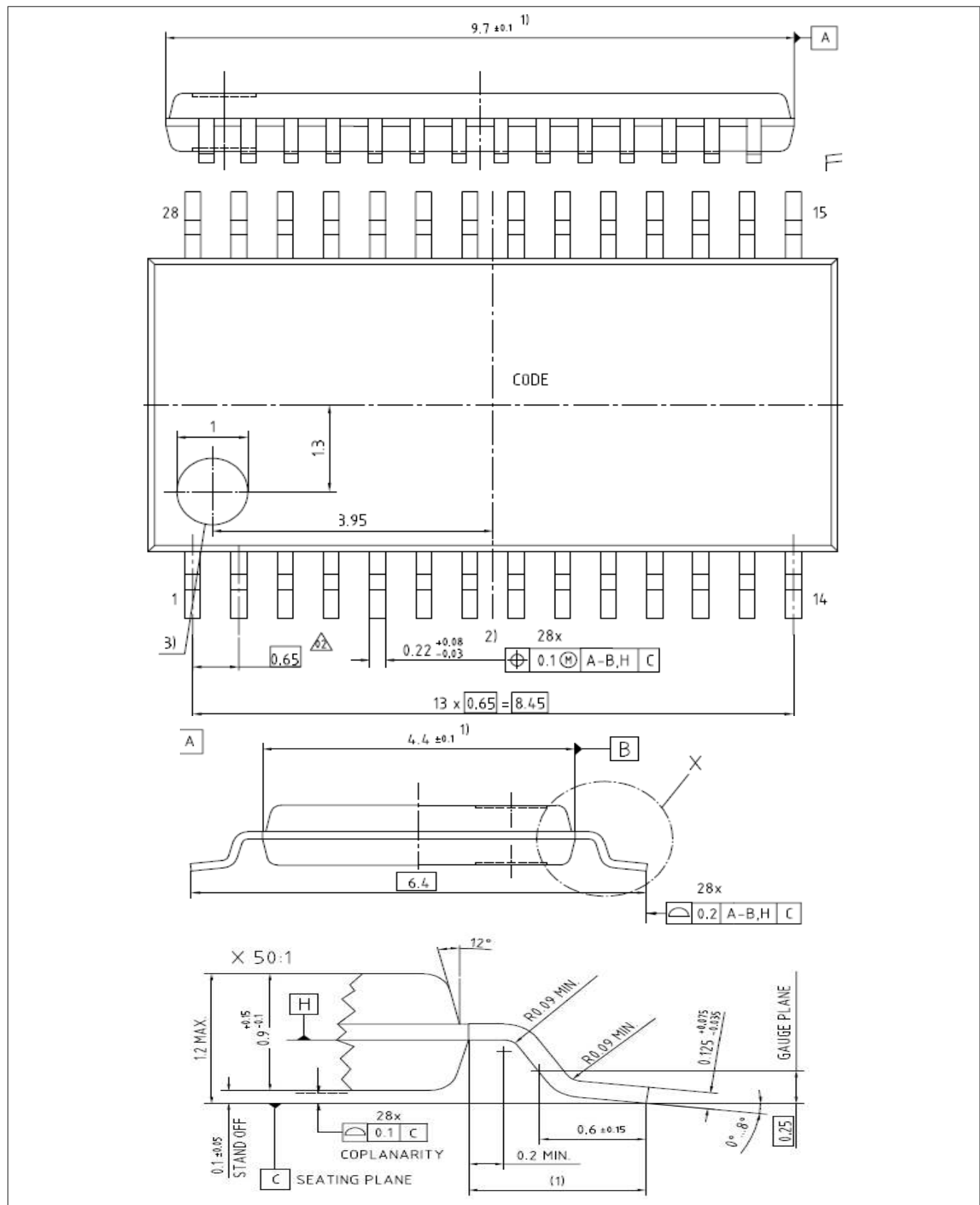


Figure 27 **PG-TSSOP-28-16**

4 Package and Reliability

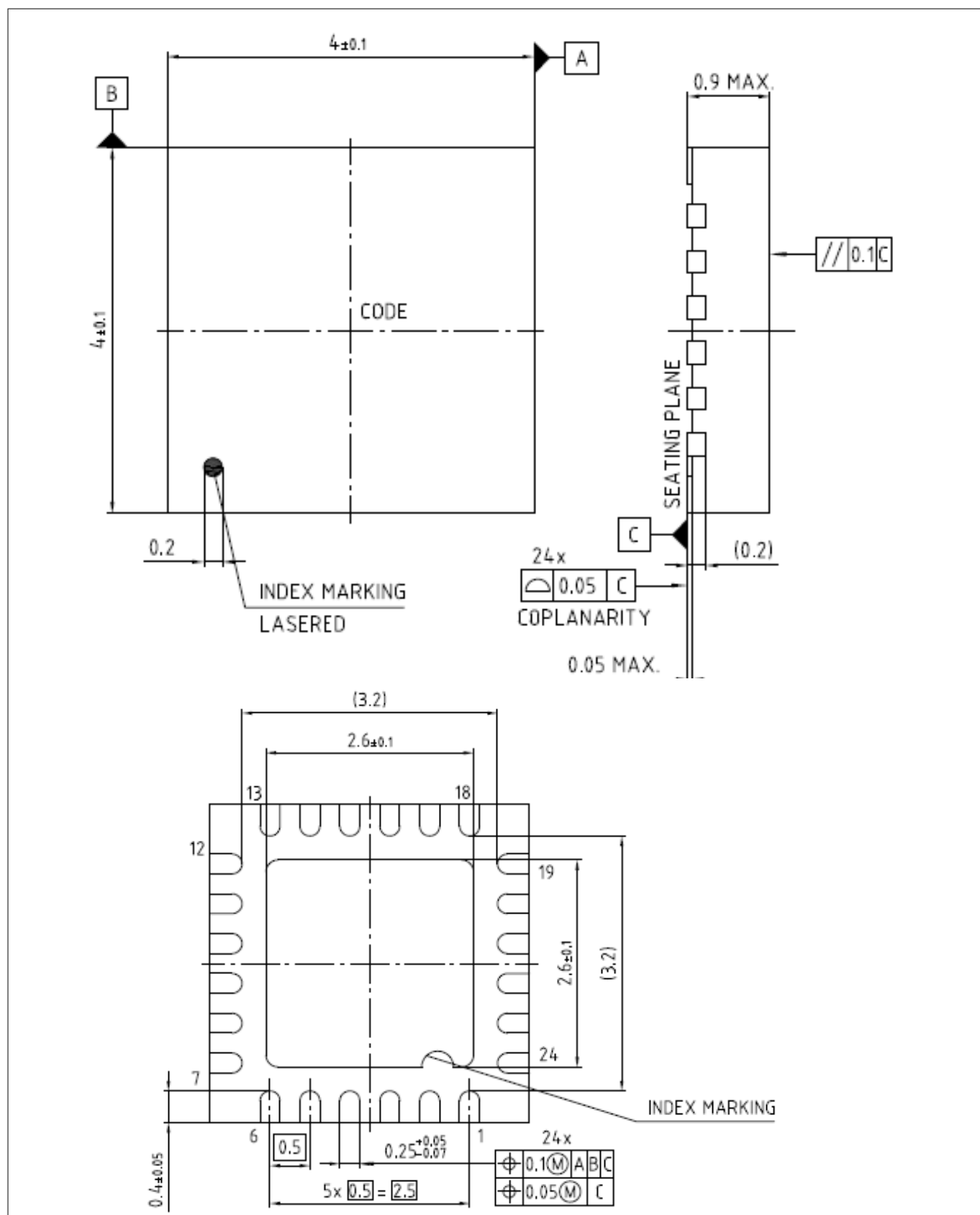


Figure 29 PG-VQFN-24-19

4 Package and Reliability

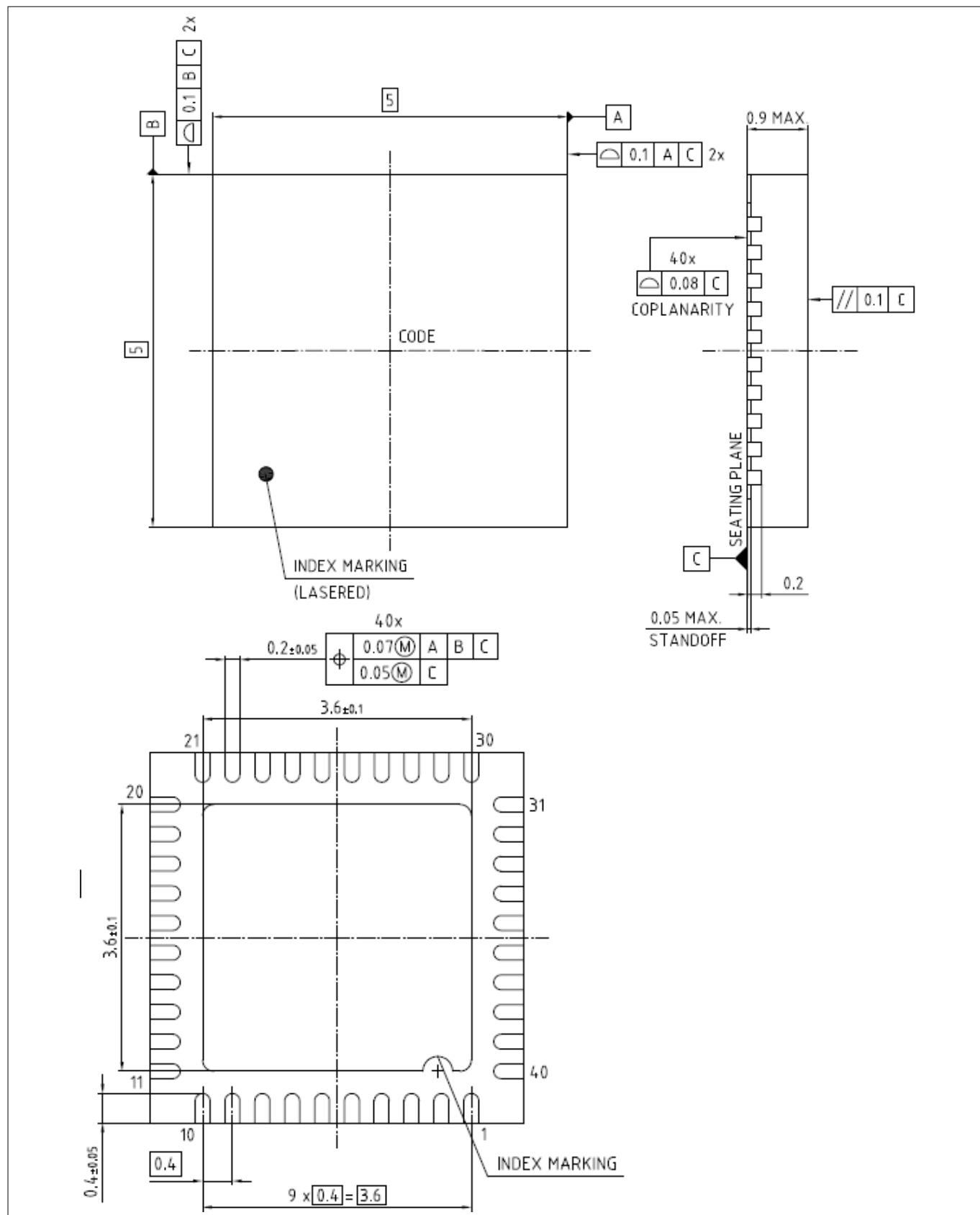


Figure 30 PG-VQFN-40-13

All dimensions in mm.

5 Quality Declaration

5 Quality Declaration

Table 36 shows the characteristics of the quality parameters in the XMC1300.

Table 36 **Quality Parameters**

Parameter	Symbol	Limit Values		Unit	Notes
		Min.	Max.		
ESD susceptibility according to Human Body Model (HBM)	V_{HBM} SR	–	4000	V	Conforming to EIA/JESD22-A114-B
ESD susceptibility according to Charged Device Model (CDM) pins	V_{CDM} SR	–	1000	V	Conforming to JESD22-C101-C
Moisture sensitivity level	MSL CC	–	–	–	JEDEC J-STD-020D
• TSSOP-16, TSSOP-28, TSSOP-38			3		
• VQFN-24, VQFN-40			1		
Soldering temperature	T_{SDR} SR	–	260	°C	Profile according to JEDEC J-STD-020D

Revision history

Revision history

Document revision	Date	Description of changes
V2.0	2017-10	Add marking option for XMC1302-T28X0032, XMC1302-T28X0064, XMC1302-T28X0128, XMC1302-T28X0200.
V2.1	2025-01-22	Updated template. Updated Moisture sensitivity level in Quality Declaration section.
V2.2	2025-06-30	Updated ESD ratings in Table 36

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